

Operational Amplifiers / Comparators

High Speed with High Voltage Operational Amplifiers



BA3472, BA3472R, BA3474, BA3474R

General Description

General-purpose BA3472,BA3472R,BA3474,BA3474R integrate two/four Independent Op-amps and phase compensation capacitors on a single chip and have some features of high-gain, and wide operating voltage range of +3[V] to +36[V](single power supply). Especially, characteristics are high slew rate (10[V/μs]) and high Maximum frequency (4[MHz]).

Features

- Operable with a single power supply
- Wide operating supply voltage
- Standard Op-Amp. Pin-assignments
- Internal phase compensation
- High open loop voltage gain
- Internal ESD protection
- Operable low input voltage around GND level
- Wide output voltage range

Packages

	(Typ.)	(Typ.)	(Max.)
MSOP8	2.90mm	4.00mm	0.90mm
SSOP-B8	3.00mm	6.40mm	1.35mm
SSOP-B14	5.00mm	6.40mm	1.35mm
SOP8	5.00mm	6.20mm	1.71mm
SOP14	8.70mm	6.20mm	1.71mm

Key Specifications

- Wide Operating Supply Voltage:

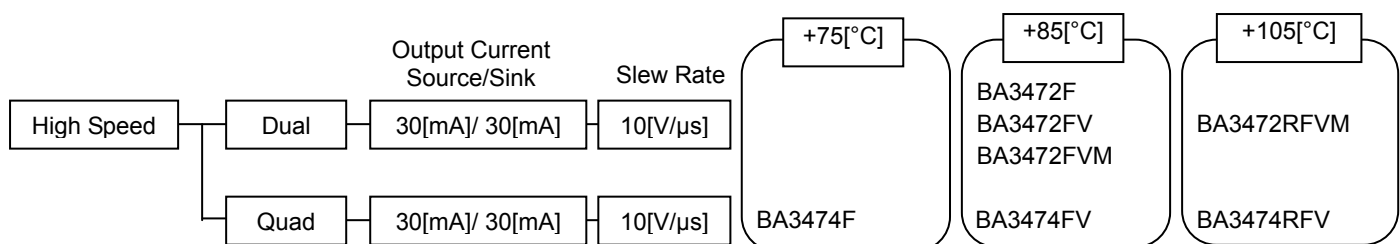
Single supply	+3.0[V] to +36.0[V]
Dual supply	±1.5[V] to ±18.0[V]
- Wide Temperature Range:

BA3474F	-40[°C] to +75[°C]
BA3472F BA3472FV	
BA3472FVM BA3474FV	-40[°C] to +85[°C]
BA3472RFVM	
BA3474RFV	-40[°C] to +105[°C]
- Low Input Offset Current: 6[nA] (Typ.)
- Low Input Bias Current: 100[nA] (Typ.)
- Wide Output Voltage Range:

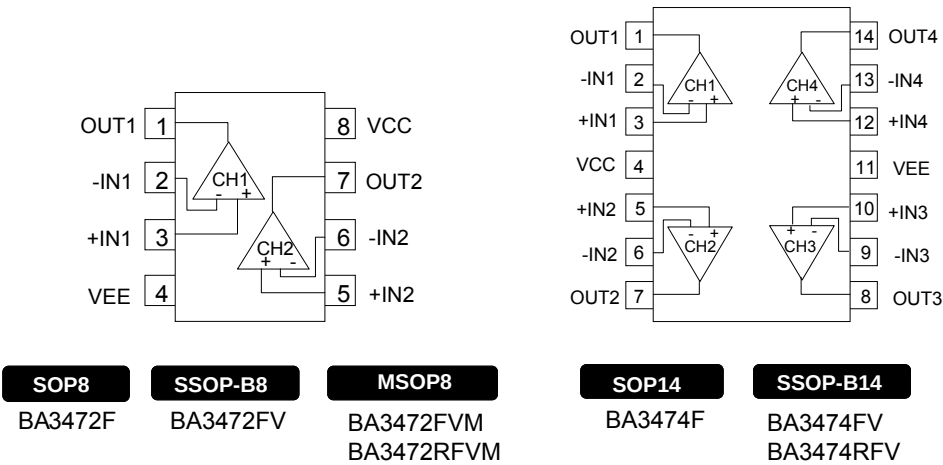
VEE+0.3[V]-VCC-1.0[V](Typ.)
with VCC-VEE=30[V]
- High Slew Rate: 10[V/μs]
- Maximum Frequency: 4[MHz]
- Human Body Model (HBM): ±5000[V] (Typ.)

Selection Guide

Operation guaranteed



●Pin Configuration(TOP VIEW)



●Ordering Information

B A 3 4 7 x F x x - x x									
Part Number				Package			Packaging and forming specification		
				F : SOP8			E2: Embossed tape and reel		
				SOP14			(SOP8/SOP14/SSOP-B8/SSOP-B14)		
				FV : SSOP-B8			TR: Embossed tape and reel		
				SSOP-B14			(MSOP8)		
				FVM: MSOP8					

●Lineup

Topr	Supply Current (Typ.)	Slew Rate (Typ.)	Package		Orderable Part Number
-40°C to +75°C	8.0mA	10.0V/μs	SOP14	Reel of 2500	BA3474F-E2
-40°C to +85°C	4.0mA		SOP8	Reel of 2500	BA3472F-E2
			SSOP-B8	Reel of 2500	BA3472FV-E2
	8.0mA		MSOP8	Reel of 3000	BA3472FVM-TR
			SSOP-B14	Reel of 2500	BA3474FV-E2
	-40°C to +105°C		4.0mA	MSOP8	Reel of 3000
8.0mA			SSOP-B14	Reel of 2500	BA3474RFV-E2

Absolute Maximum Ratings (Ta=25[°C])

Parameter	Symbol	Ratings		Unit
		BA3472 BA3474	BA3472R BA3474R	
Supply Voltage	VCC-VEE	+36		V
Differential Input Voltage ^(*)	Vid	36		V
Input Common-mode Voltage Range	Vicm	(VEE - 0.3) to VEE + 36		V
Operating Temperature Range	Topr	-40 to +85(SOP14:+75)	-40 to +105	°C
Storage Temperature Range	Tstg	-55 to +150		°C
Maximum Junction Temperature	Tjmax	+150		°C

Note: Absolute maximum rating item indicates the condition which must not be exceeded.

Application if voltage in excess of absolute maximum rating or use out of absolute maximum rated temperature environment may cause deterioration of characteristics.

(*) The voltage difference between inverting input and non-inverting input is the differential input voltage.
Then input terminal voltage is set to more than VEE.

Electrical Characteristics

OBA3472 (Unless otherwise specified VCC=+15[V], VEE=-15[V], Ta=25[°C])

Parameter	Symbol	Temperature range	Limits			Unit	Condition
			BA3472F/FV/FVM				
			Min.	Typ.	Max.		
Input Offset Voltage (*2)	Vio	25°C	-	1	10	mV	Vicm=0[V],VOUT=0[V]
			-	1.5	10		VCC=5[V],VEE=0[V],Vicm=0[V], VOUT=VCC/2
Input Offset Current (*2)	Iio	25°C	-	6	75	nA	Vicm=0[V],VOUT=0[V]
Input Bias Current (*2)	Ib	25°C	-	100	500	nA	Vicm=0[V],VOUT=0[V]
Supply Current	ICC	25°C	-	4	5.5	mA	RL=∞
High Level Output Voltage	VOH	25°C	3.7	4	-	V	VCC=5[V],RL=2[kΩ]
			13.7	14	-		RL=10[kΩ]
			13.5	-	-		RL=2[kΩ]
Low Level Output Voltage	VOL	25°C	-	0.1	0.3	V	VCC=5[V],RL=2[kΩ]
			-	-14.7	-14.3		RL=10[kΩ]
			-	-	-13.5		RL=2[kΩ]
Large Signal Voltage Gain	AV	25°C	80	100	-	dB	RL≥2[kΩ],VOUT=±10 [V]
Input Common-mode Voltage Range	Vicm	25°C	0	-	VCC-2.0	V	VCC=5[V],VEE=0[V], VOUT=VCC/2
Common-mode Rejection Ratio	CMRR	25°C	60	97	-	dB	Vicm=0[V],VOUT=0[V]
Power Supply Rejection Ratio	PSRR	25°C	60	97	-	dB	Vicm=0[V],VOUT=0[V]
Output Source Current (*3)	IOH	25°C	10	30	-	mA	VCC=5[V],VIN+=1[V], VIN-=0[V],VOUT=0[V] Only 1ch is short circuit
Output Sink Current (*3)	IOL	25°C	20	30	-	mA	VCC=5[V],VIN+=0[V], VIN-=1[V],VOUT=5[V], Only 1ch is short circuit
Maximum Frequency	ft	25°C	-	4	-	MHz	-
Slew Rate	SR	25°C	-	10	-	V/μs	Av=1,Vin=- 10 to +10[V], RL=2[kΩ]
Channel Separation	CS	25°C	-	120	-	dB	-

(*2) Absolute value

(*3) Under high temperatures, please consider the power dissipation when selecting the output current.

When the output terminal is continuously shorted the output current reduces the internal temperature by flushing.

OBA3472R (Unless otherwise specified VCC=+15[V], VEE=-15[V], Ta=25[°C])

Parameter	Symbol	Temperature range	Limits			Unit	Condition
			BA3472RFVM				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*4)	Vio	25°C	-	1	10	mV	Vicm=0[V],VOUT=0[V]
			-	1.5	10		VCC=5[V],VEE=0[V],Vicm=0[V], VOUT=VCC/2
Input Offset Current ^(*4)	Iio	25°C	-	6	75	nA	Vicm=0[V],VOUT=0[V]
Input Bias Current ^(*4)	Ib	25°C	-	100	500	nA	Vicm=0[V],VOUT=0[V]
Supply Current	ICC	25°C	-	4	5.5	mA	RL=∞
High Level Output Voltage	VOH	25°C	3.7	4	-	V	VCC=5[V],RL=2[kΩ]
			13.7	14	-		RL=10[kΩ]
			13.5	-	-		RL=2[kΩ]
Low Level Output Voltage	VOL	25°C	-	0.1	0.3	V	VCC=5[V],RL=2[kΩ]
			-	-14.7	-14.3		RL=10[kΩ]
			-	-	-13.5		RL=2[kΩ]
Large Signal Voltage Gain	AV	25°C	80	100	-	dB	RL≥2[kΩ],VOUT=±10 [V]
Input Common-mode Voltage Range	Vicm	25°C	0	-	VCC-2.0	V	VCC=5[V],VEE=0[V], VOUT=VCC/2
Common-mode Rejection Ratio	CMRR	25°C	60	97	-	dB	Vicm=0[V],VOUT=0[V]
Power Supply Rejection Ratio	PSRR	25°C	60	97	-	dB	Vicm=0[V],VOUT=0[V]
Output Source Current ^(*5)	IOH	25°C	10	30	-	mA	VCC=5[V],VIN+=1[V], VIN-=0[V], VOUT=0[V] Only 1ch is short circuit
Output Sink Current ^(*5)	IOL	25°C	20	30	-	mA	VCC=5[V],VIN+=0[V], VIN-=1[V], VOUT=5[V] Only 1ch is short circuit
Maximum Frequency	ft	25°C	-	4	-	MHz	-
Slew Rate	SR	25°C	-	10	-	V/μs	Av=1,Vin=-10 to +10[V], RL=2[kΩ]
Channel Separation	CS	25°C	-	120	-	dB	-

(*4) Absolute value

(*5) Under high temperatures, please consider the power dissipation when selecting the output current.

When the output terminal is continuously shorted the output current reduces the internal temperature by flushing.

OBA3474 (Unless otherwise specified VCC=+15[V], VEE=-15[V], Ta=25[°C])

Parameter	Symbol	Temperature range	Limits			Unit	Condition
			BA3474F/FV				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*6)	Vio	25°C	-	1	10	mV	Vicm=0[V],VOUT=0[V]
			-	1.5	10		VCC=5[V],VEE=0[V], Vicm=0[V] VOUT=VCC/2
Input Offset Current ^(*6)	Iio	25°C	-	6	75	nA	Vicm=0[V],VOUT=0[V]
Input Bias Current ^(*6)	Ib	25°C	-	100	500	nA	Vicm=0[V],VOUT=0[V]
Supply Current	ICC	25°C	-	8	11	mA	RL=∞
High Level Output Voltage	VOH	25°C	3.7	4	-	V	VCC=5[V],RL=2[kΩ]
			13.7	14	-		RL=10[kΩ]
			13.5	-	-		RL=2[kΩ]
Low Level Output Voltage	VOL	25°C	-	0.1	0.3	V	VCC=5[V],RL=2[kΩ]
			-	-14.7	-14.3		RL=10[kΩ]
			-	-	-13.5		RL=2[kΩ]
Large Signal Voltage Gain	AV	25°C	80	100	-	dB	RL≥2[kΩ], VOUT=±10 [V]
Input Common-mode Voltage Range	Vicm	25°C	0	-	VCC-2.0	V	VCC=5[V],VEE=0[V], VOUT=VCC/2
Common-mode Rejection Ratio	CMRR	25°C	60	97	-	dB	Vicm=0[V],VOUT=0[V]
Power Supply Rejection Ratio	PSRR	25°C	60	97	-	dB	Vicm=0[V],VOUT=0[V]
Output Source Current ^(*7)	IOH	25°C	10	30	-	mA	VCC=5[V],VIN+=1[V], VIN-=0[V], VOUT=0[V] Only 1ch is short circuit
Output Sink Current ^(*7)	IOL	25°C	20	30	-	mA	VCC=5[V],VIN+=0[V], VIN-=1[V], VOUT=5[V] Only 1ch is short circuit
Maximum Frequency	ft	25°C	-	4	-	MHz	-
Slew Rate	SR	25°C	-	10	-	V/μs	Av=1,Vin=-10 to +10[V], RL=2[kΩ]
Channel Separation	CS	25°C	-	120	-	dB	-

(*6) Absolute value

(*7) Under high temperatures, please consider the power dissipation when selecting the output current.

When the output terminal is continuously shorted the output current reduces the internal temperature by flushing.

OBA3474R (Unless otherwise specified VCC=+15[V], VEE=-15[V], Ta=25[°C])

Parameter	Symbol	Temperature range	Limits			Unit	Condition
			BA3474RFV				
			Min.	Typ.	Max.		
Input Offset Voltage ^(*)8)	Vio	25°C	-	1	10	mV	Vicm=0[V],VOUT=0[V]
			-	1.5	10		VCC=5[V],VEE=0[V],Vicm=0[V],VOUT=VCC/2
Input Offset Current ^(*)8)	Iio	25°C	-	6	75	nA	Vicm=0[V],VOUT=0[V]
Input Bias Current ^(*)8)	Ib	25°C	-	100	500	nA	Vicm=0[V],VOUT=0[V]
Supply Current	ICC	25°C	-	8	11	mA	RL=∞
High Level Output Voltage	VOH	25°C	3.7	4	-	V	VCC=5[V],RL=2[kΩ]
			13.7	14	-		RL=10[kΩ]
			13.5	-	-		RL=2[kΩ]
Low Level Output Voltage	VOL	25°C	-	0.1	0.3	V	VCC=5[V],RL=2[kΩ]
			-	-14.7	-14.3		RL=10[kΩ]
			-	-	-13.5		RL=2[kΩ]
Large Signal Voltage Gain	AV	25°C	80	100	-	dB	RL≥2[kΩ],VOUT=±10 [V]
Input Common-mode Voltage Range	Vicm	25°C	0	-	VCC-2.0	V	VCC=5[V],VEE=0[V],VOUT=VCC/2
Common-mode Rejection Ratio	CMRR	25°C	60	97	-	dB	Vicm=0[V],VOUT=0[V]
Power Supply Rejection Ratio	PSRR	25°C	60	97	-	dB	Vicm=0[V],VOUT=0[V]
Output Source Current ^(*)9)	IOH	25°C	10	30	-	mA	VCC=5[V],VIN+=1[V],VIN-=0[V],VOUT=0[V], Only 1ch is short circuit
Output Sink Current ^(*)9)	IOL	25°C	20	30	-	mA	VCC=5[V],VIN+=0[V],VIN-=1[V],VOUT=5[V], Only 1ch is short circuit
Maximum Frequency	ft	25°C	-	4	-	MHz	-
Slew Rate	SR	25°C	-	10	-	V/μs	Av=1,Vin=-10 to +10[V],RL=2[kΩ]
Channel Separation	CS	25°C	-	120	-	dB	-

(*)8) Absolute value

(*)9) Under high temperatures, please consider the power dissipation when selecting the output current.

When the output terminal is continuously shorted the output current reduces the internal temperature by flushing.

Description of Electrical Characteristics

Described below are descriptions of the relevant electrical terms

Please note that item names, symbols and their meanings may differ from those on another manufacturer's documents.

1. Absolute maximum ratings

The absolute maximum ratings are values that should never be exceeded, since doing so may result in deterioration of electrical characteristics or damage to the part itself as well as peripheral components.

1.1 Power supply voltage (VCC-VEE)

Expresses the maximum voltage that can be supplied between the positive and negative supply terminals without causing deterioration of the electrical characteristics or destruction of the internal circuitry.

1.2 Differential input voltage (Vid)

Indicates the maximum voltage that can be supplied between the non-inverting and inverting terminals without damaging the IC.

1.3 Input common-mode voltage range (Vicm)

Signifies the maximum voltage that can be supplied to non-inverting and inverting terminals without causing deterioration of the characteristics or damage to the IC itself. Normal operation is not guaranteed within the common-mode voltage range of the maximum ratings – use within the input common-mode voltage range of the electric characteristics instead.

1.4 Power dissipation (Pd)

Indicates the power that can be consumed by a particular mounted board at ambient temperature (25°C). For packaged products, Pd is determined by the maximum junction temperature and the thermal resistance.

2. Electrical characteristics**2.1 Input offset voltage (Vio)**

Signifies the voltage difference between the non-inverting and inverting terminals. It can be thought of as the input voltage difference required for setting the output voltage to 0 V.

2.2 Input offset current (Iio)

Indicates the difference of input bias current between the non-inverting and inverting terminals.

2.3 Input bias current (Ib)

Denotes the current that flows into or out of the input terminal, it is defined by the average of the input bias current at the non-inverting terminal and the input bias current at the inverting terminal.

2.4 Circuit current (ICC)

Indicates the current of the IC itself that flows under specified conditions and during no-load steady state.

2.5 maximum output voltage (VOM)

Indicates the voltage range that can be output by the IC under specified load condition. It is typically divided into high-level output voltage and low-level output voltage.

2.6 Large signal voltage gain (AV)

The amplifying rate (gain) of the output voltage against the voltage difference between non-inverting and inverting terminals, it is (normally) the amplifying rate (gain) with respect to DC voltage.

$$AV = (\text{output voltage fluctuation}) / (\text{input offset fluctuation})$$

2.7 Input common-mode voltage range (Vicm)

Indicates the input voltage range under which the IC operates normally.

2.8 Common-mode rejection ratio (CMRR)

Signifies the ratio of fluctuation of the input offset voltage when the in-phase input voltage is changed (DC fluctuation).

$$CMRR = (\text{change in input common-mode voltage}) / (\text{input offset fluctuation})$$

2.9 Power supply rejection ratio (PSRR)

Denotes the ratio of fluctuation of the input offset voltage when supply voltage is changed (DC fluctuation).

$$SVR = (\text{change in power supply voltage}) / (\text{input offset fluctuation})$$

2.10 Channel separation (CS)

Expresses the amount of fluctuation of the input offset voltage or output voltage with respect to the change in the output voltage of a driven channel.

2.11 Slew rate (SR)

Indicates the time fluctuation ratio of the output voltage when an input step signal is supplied.

2.12 Maximum frequency (ft)

Indicates a frequency where the voltage gain of Op-Amp is 1.

2.13 Total harmonic distortion + Noise (THD+N)

Indicates the fluctuation of input offset voltage or that of output voltage with reference to the change of output voltage of driven channel.

2.14 Input referred noise voltage (Vn)

Indicates a noise voltage generated inside the operational amplifier equivalent by ideal voltage source connected in series with input terminal.

●Circuit Diagram

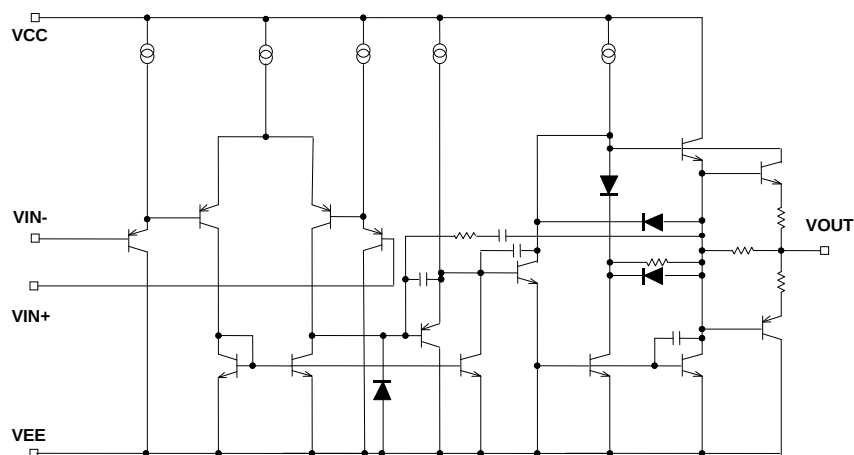
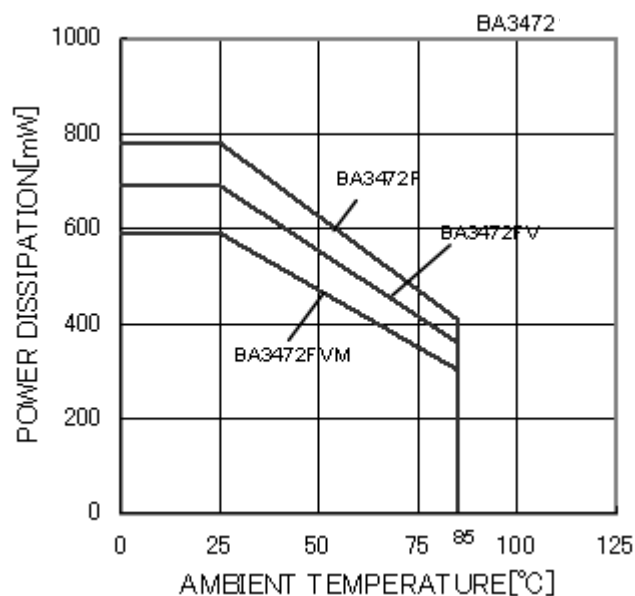
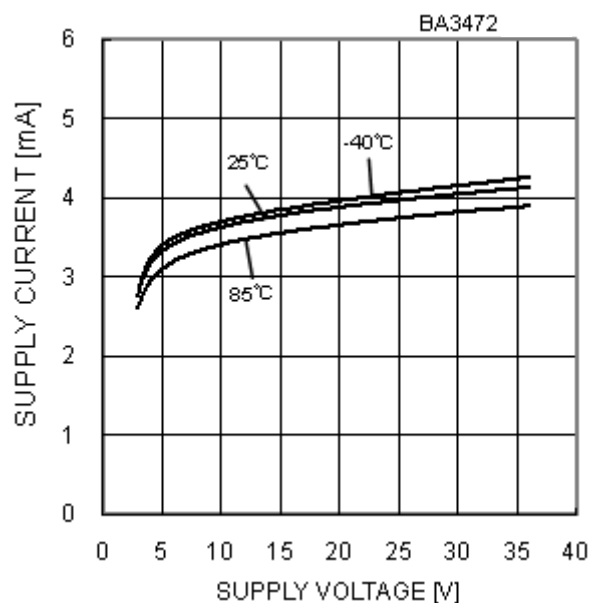
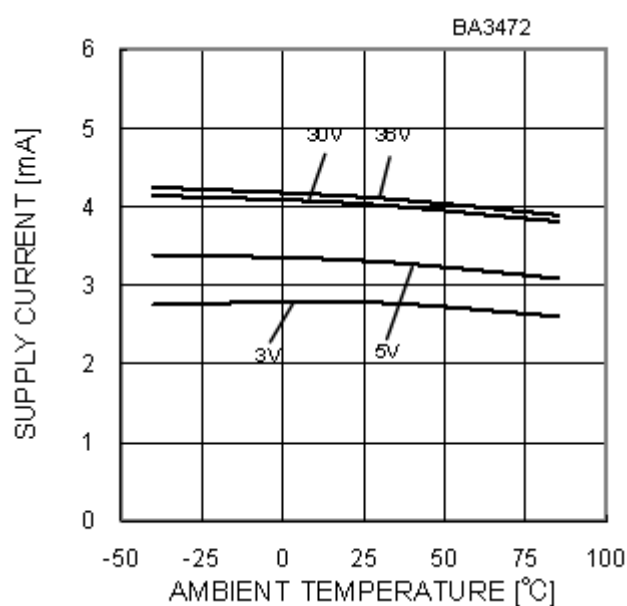
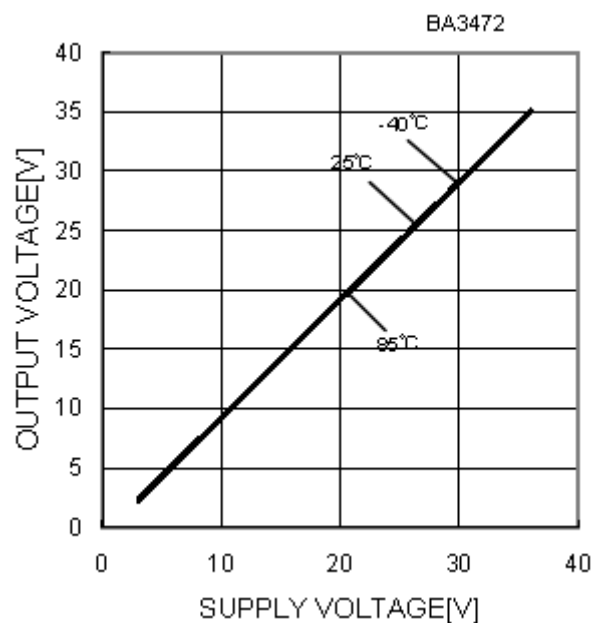


Fig.1 Schematic diagram (one channel only)

● Typical Performance Curves

BA3472

Fig.2
Derating CurveFig.3
Supply Current - Supply VoltageFig.4
Supply Current - Ambient TemperatureFig.5
High level Output Voltage - Supply Voltage
($R_L=10[k\Omega]$)

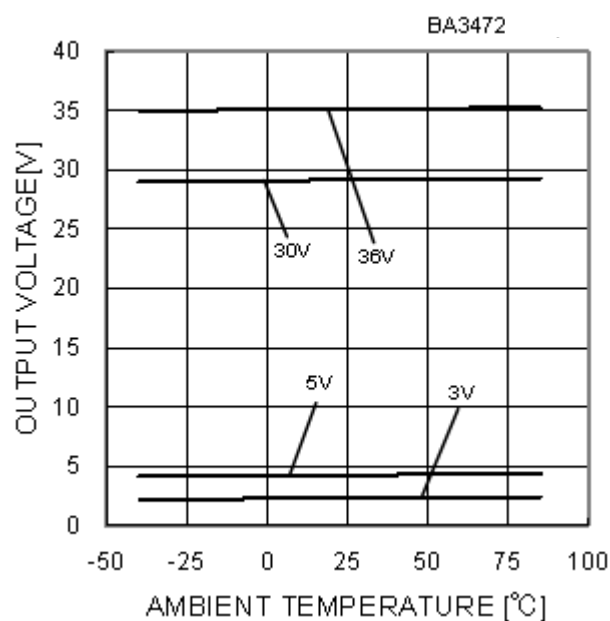


Fig.6
High level Output Voltage
- Ambient Temperature
($R_L=10[k\Omega]$)

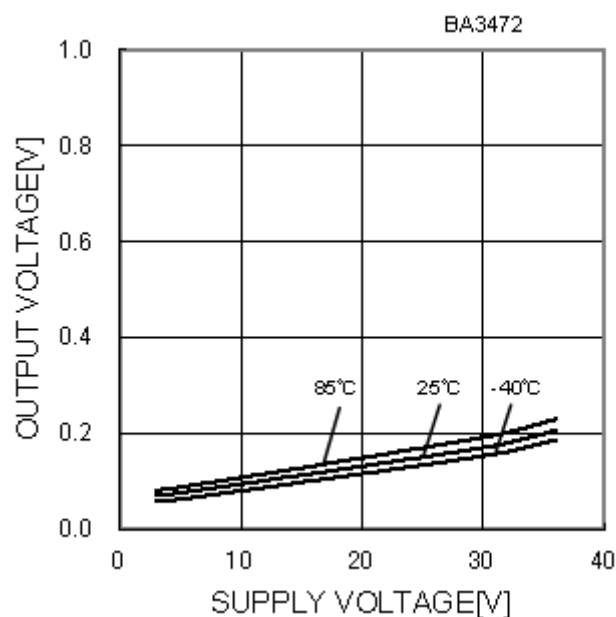


Fig.7
Low level Output Voltage
- Supply Voltage
($R_L=10[k\Omega]$)

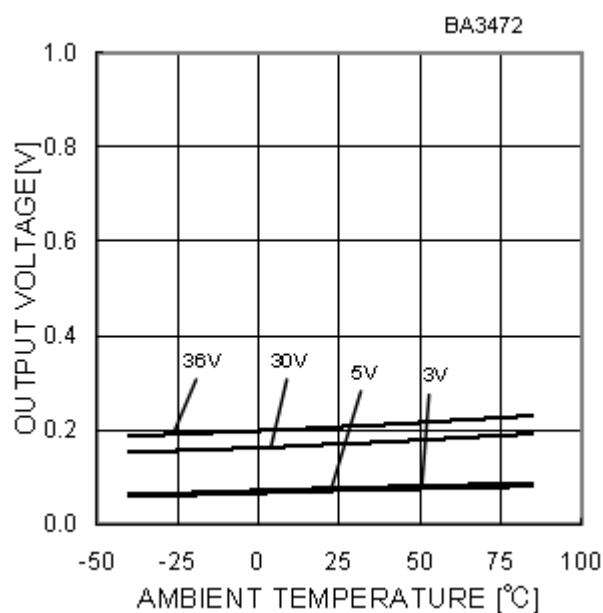


Fig.8
Low level Output Voltage
- Ambient Temperature
($R_L=10[k\Omega]$)

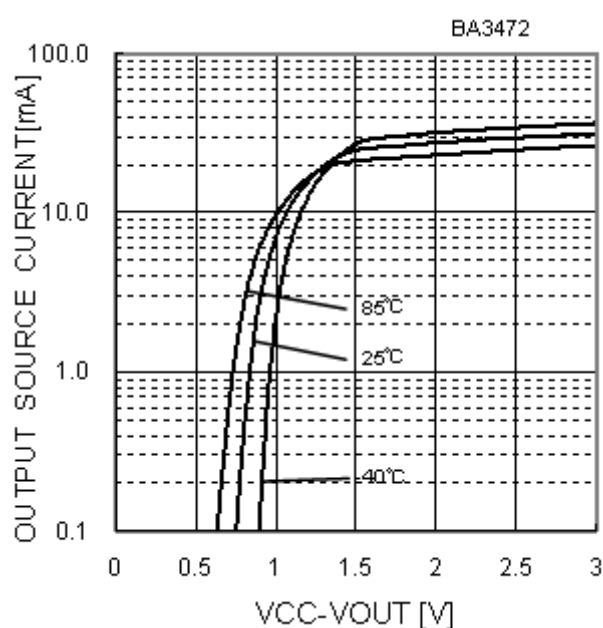


Fig.9
Output Source Current - $(V_{CC}-V_{OUT})$
($V_{CC}/V_{EE}=5[V]/0[V]$)

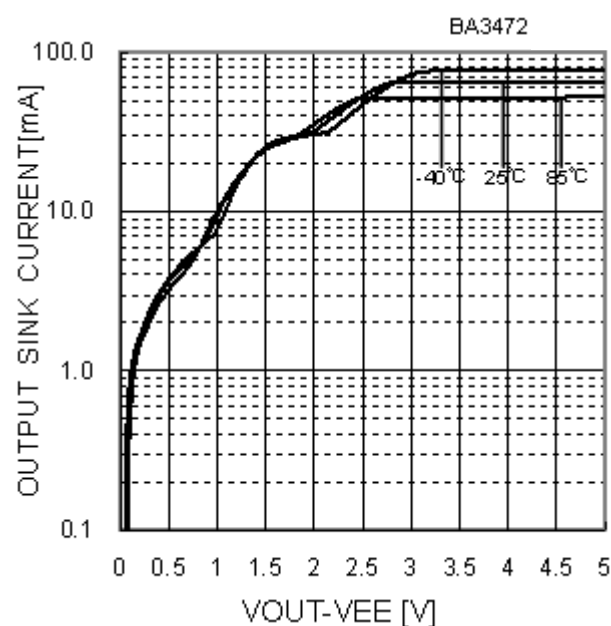


Fig.10
Output Sink Current - (VOUT-VEE)
(VCC/VEE=5[V]/0[V])

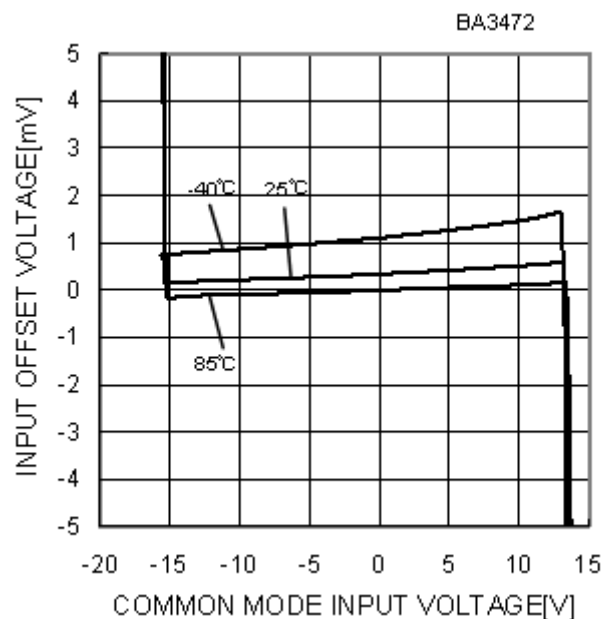


Fig.11
Input Offset Voltage
- Common Mode Input Voltage
(VCC/VEE=15[V]/-15[V])

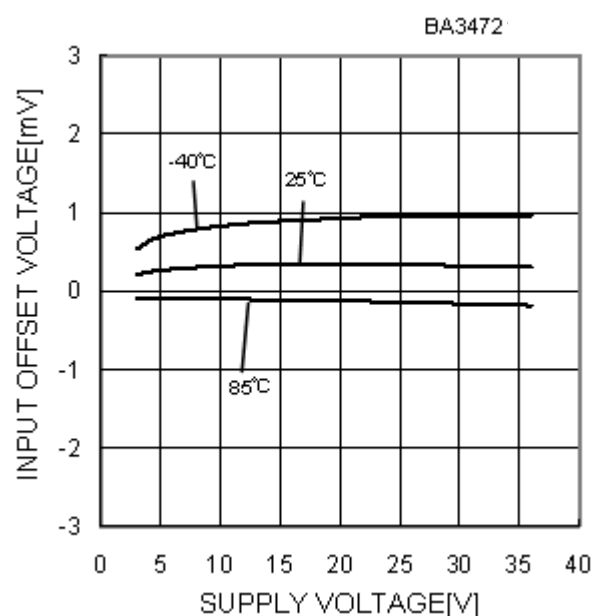


Fig.12
Input Offset Voltage - Supply voltage

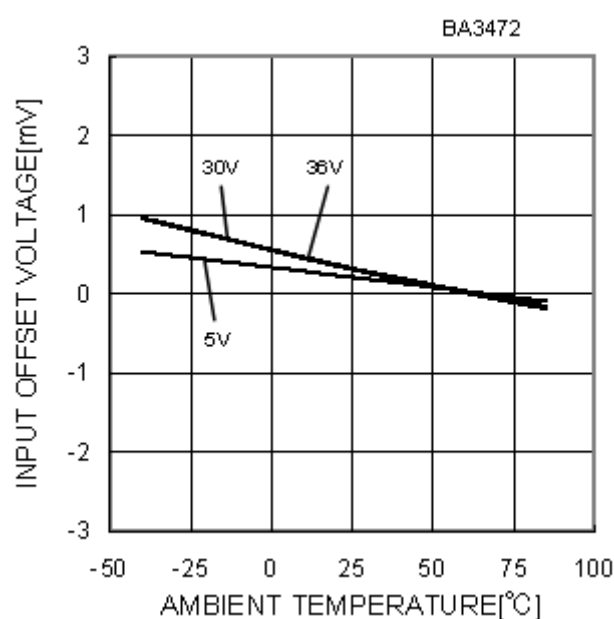


Fig.13
Input Offset Voltage - Ambient Temperature

(*)The data above is ability value of sample, it is not guaranteed

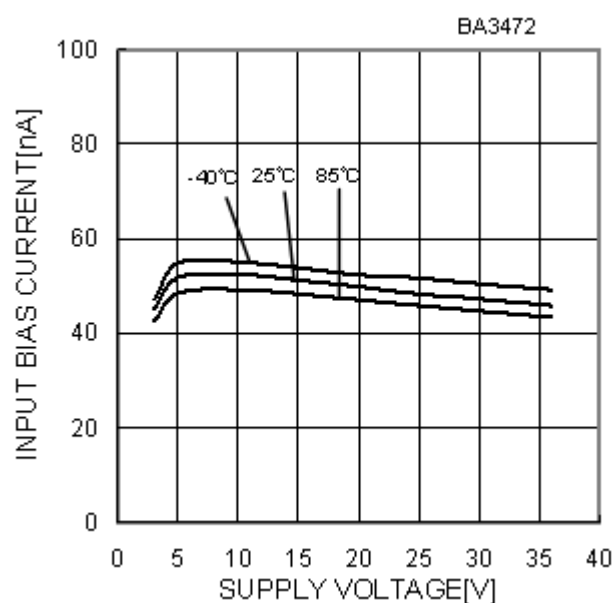


Fig. 14
Input Bias Current - Supply voltage

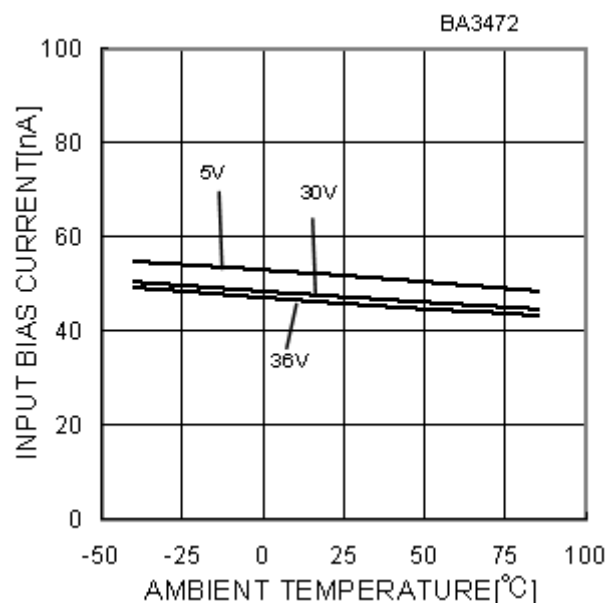


Fig. 15
Input Bias Current - Ambient Temperature

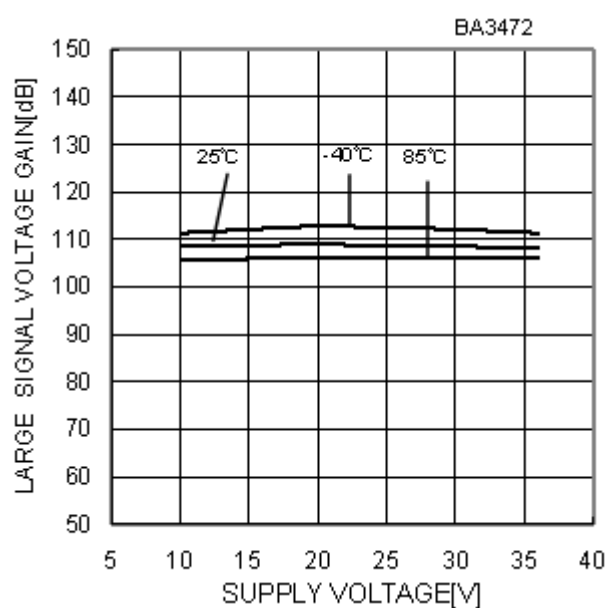


Fig. 16
Large Signal Voltage Gain
-Supply Voltage

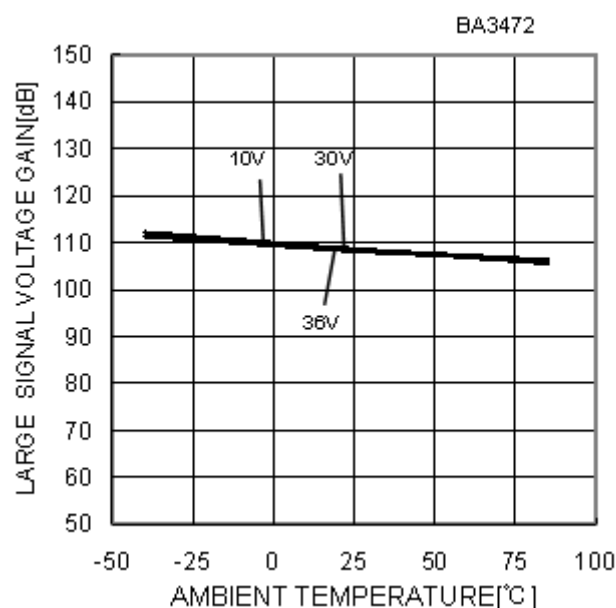


Fig. 17
Large Signal Voltage Gain
-Ambient Temperature

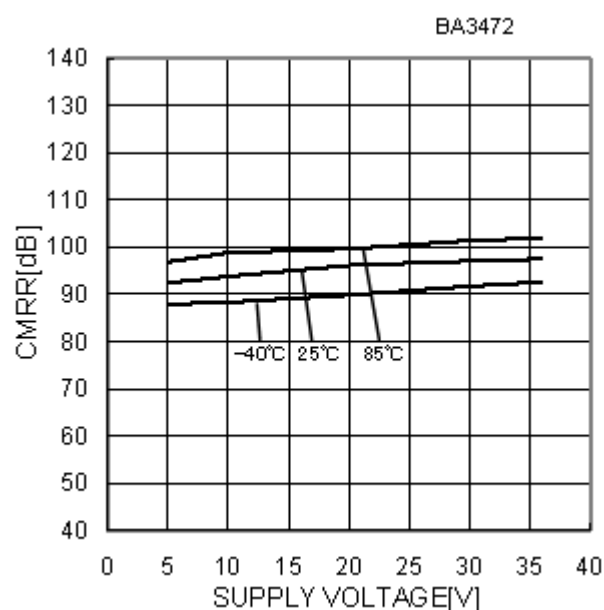


Fig.18
Common Mode Rejection Ratio
-Supply Voltage

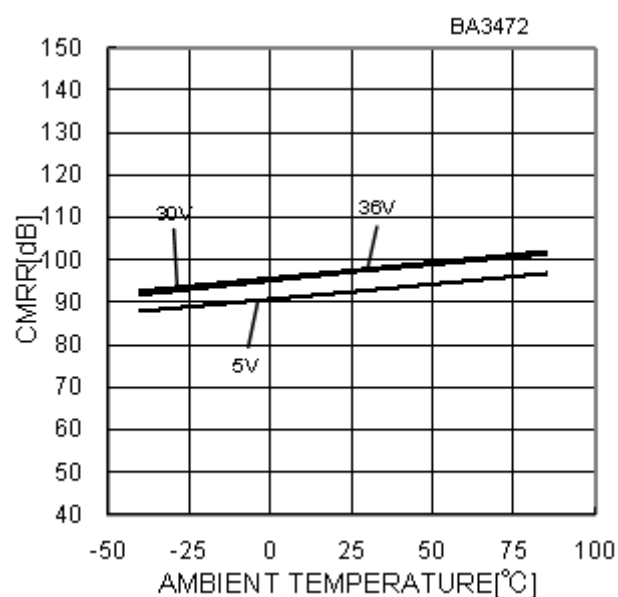


Fig.19
Common Mode Rejection Ratio
-Ambient Temperature

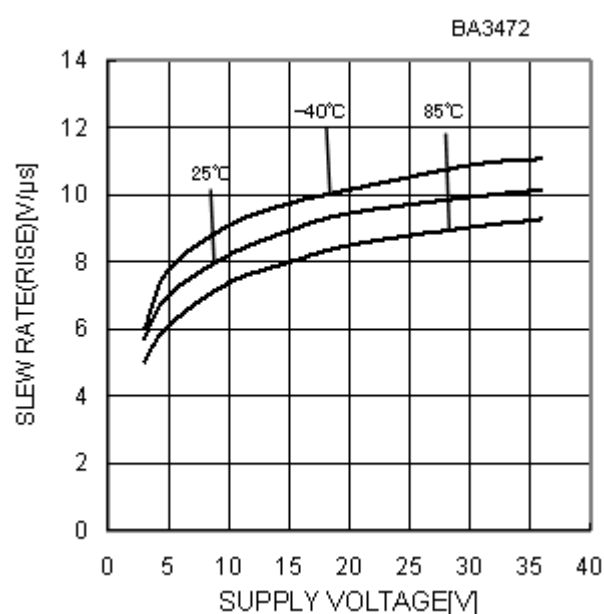


Fig.20
Slew Rate L-H - Supply Voltage
($R_L=10[k\Omega]$)

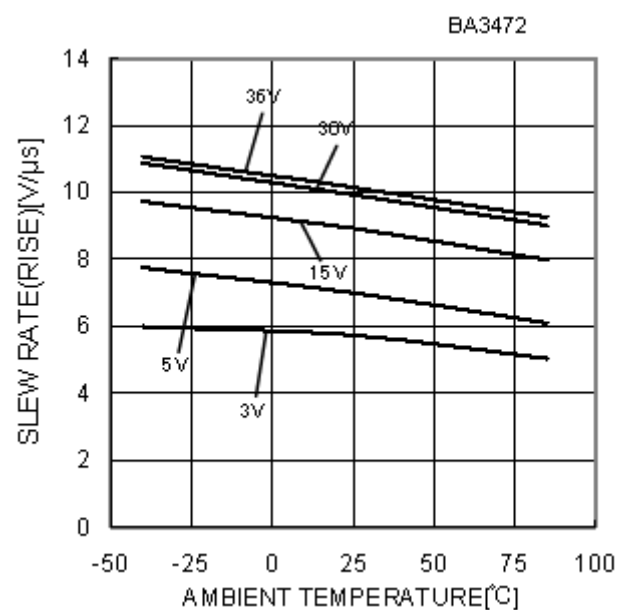


Fig.21
Slew Rate L-H - Ambient Temperature
($R_L=10[k\Omega]$)

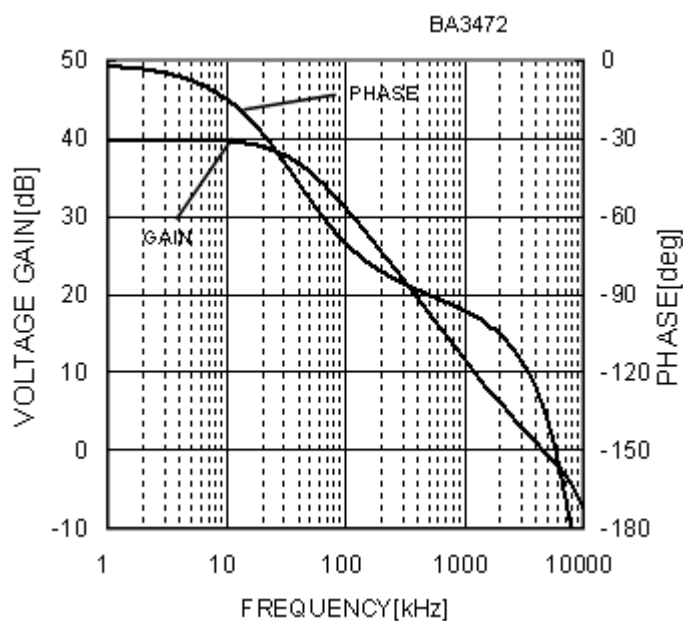


Fig.22
Voltage Gain - Frequency
($V_{CC}=7.5[V]$, $V_{EE}=-7.5[V]$, $A_v=40[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

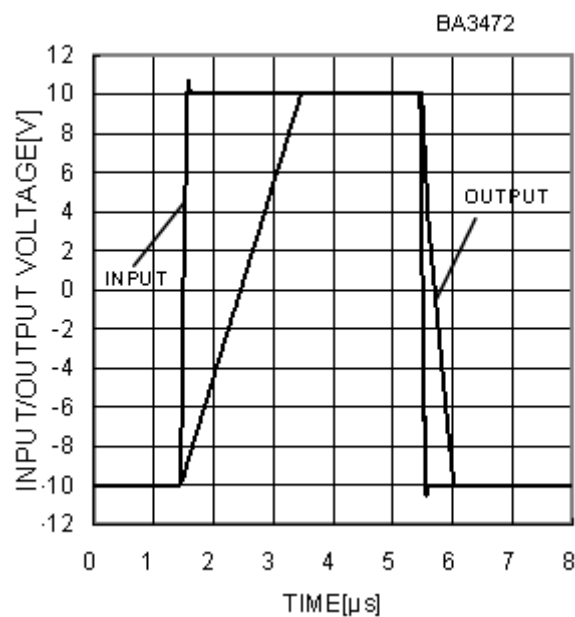


Fig.23
Input / Output Voltage - Time
($V_{CC}/V_{EE}=15[V]/-15[V]$, $A_v=0[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

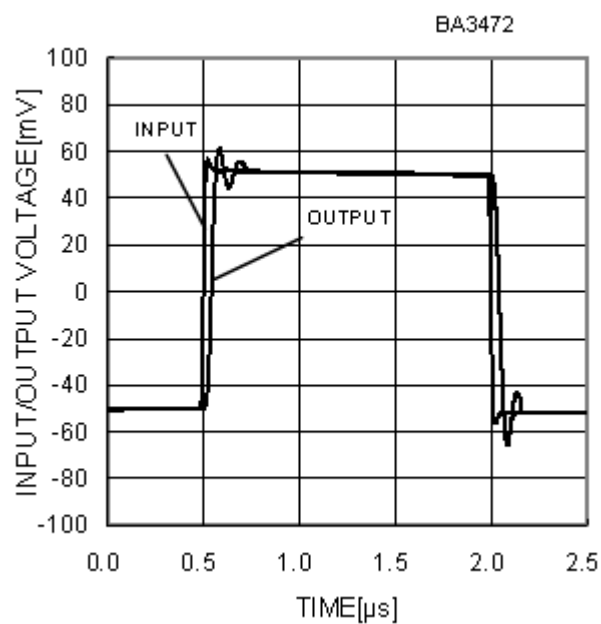


Fig.24
Input / Output Voltage - Time
($V_{CC}/V_{EE}=15[V]/-15[V]$, $A_v=0[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

(*)The data above is ability value of sample, it is not guaranteed

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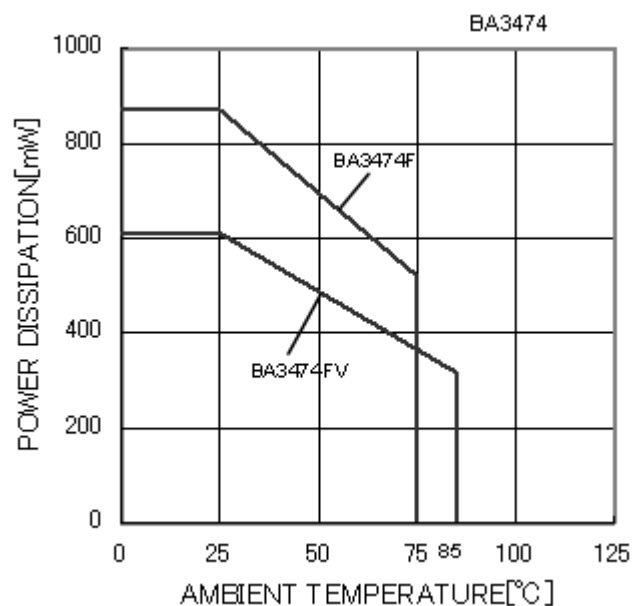


Fig.25
Derating Curve

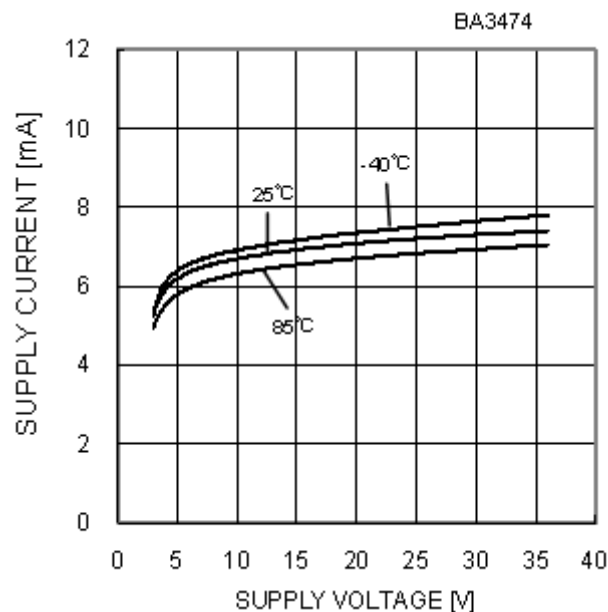


Fig.26
Supply Current - Supply Voltage

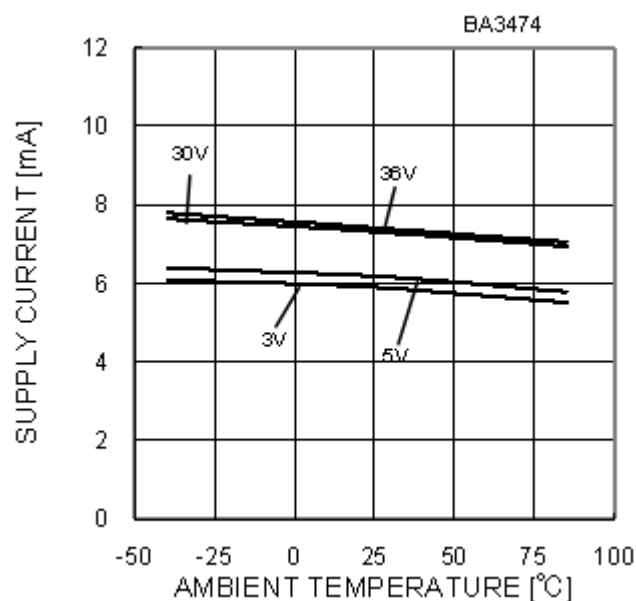


Fig.27
Supply Current - Ambient Temperature

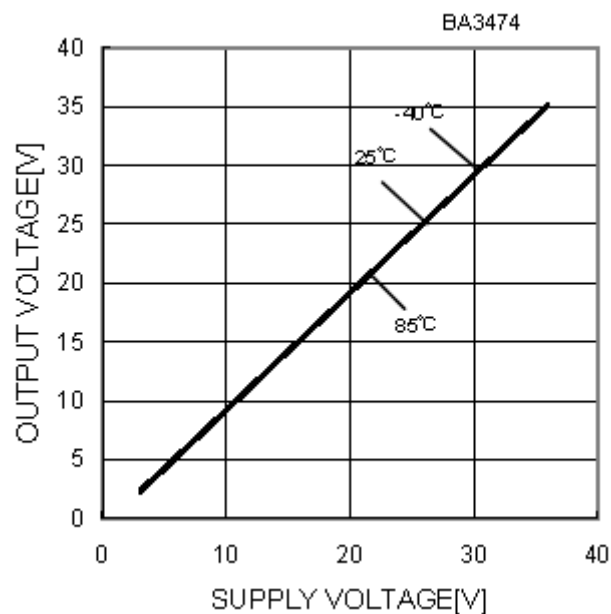


Fig.28
High level Output Voltage
- Supply Voltage
($R_L=10[k\Omega]$)

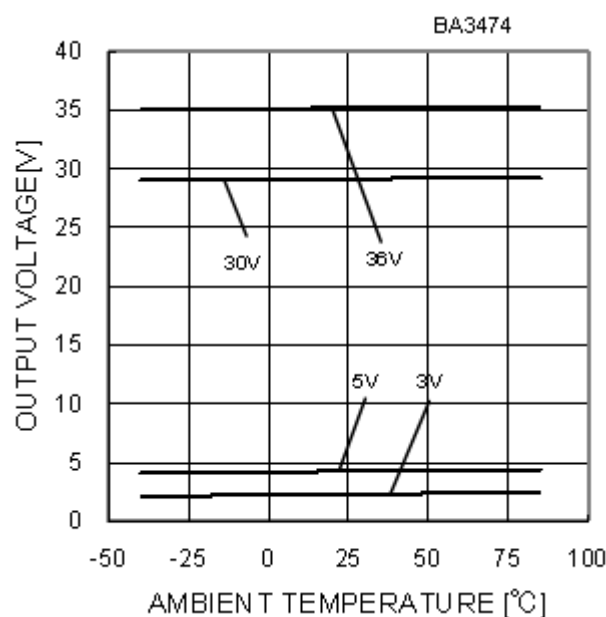


Fig.29
High level Output Voltage
- Ambient Temperature
($R_L=10[k\Omega]$)

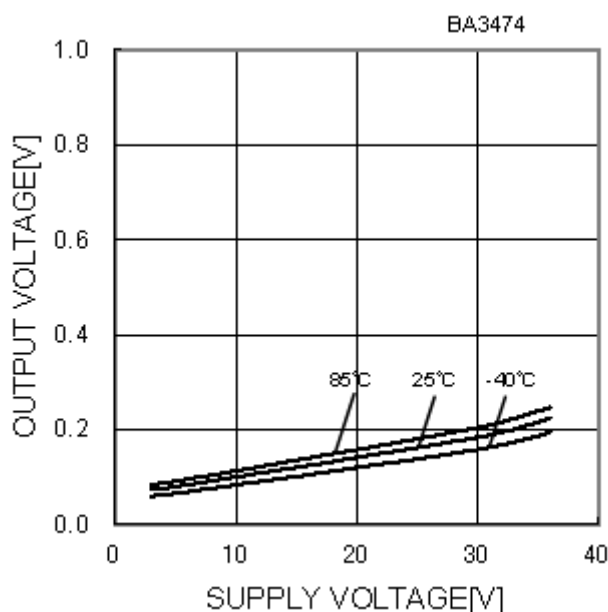


Fig.30
Low level Output Voltage
- Supply Voltage
($R_L=10[k\Omega]$)

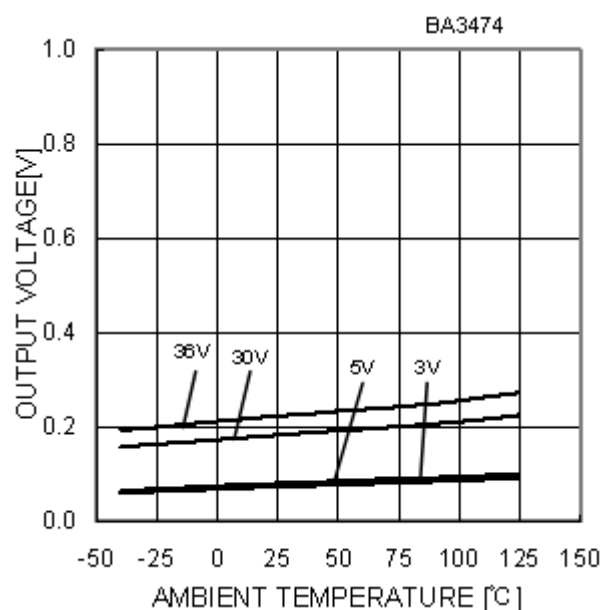


Fig.31
Low level Output Voltage
- Ambient Temperature
($R_L=10[k\Omega]$)

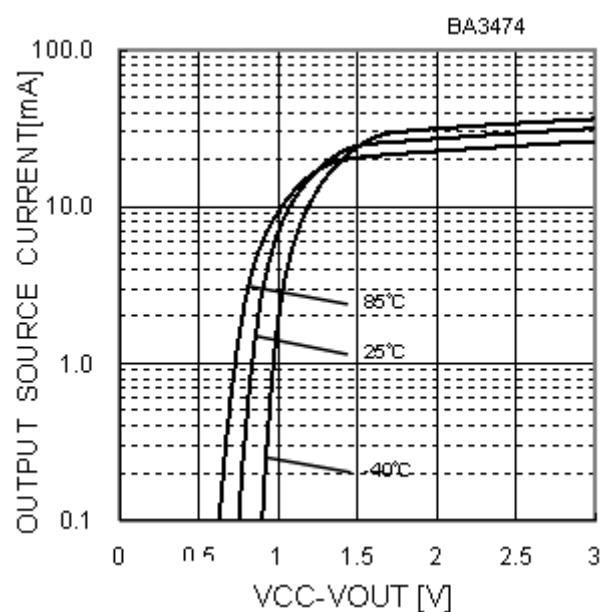


Fig.32
Output Source Current - ($V_{CC}-V_{OUT}$)
($V_{CC}/V_{EE}=5[V]/0[V]$)

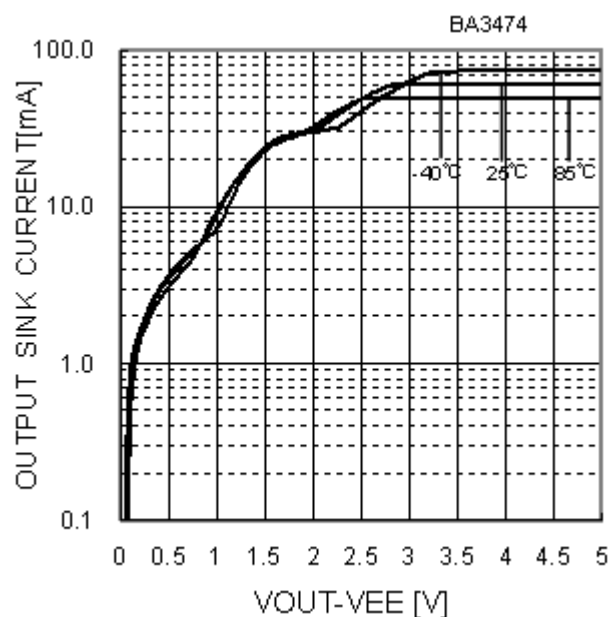


Fig.33
Output Source Current - (VOUT-VEE)
(VCC/VEE=5[V]/0[V])

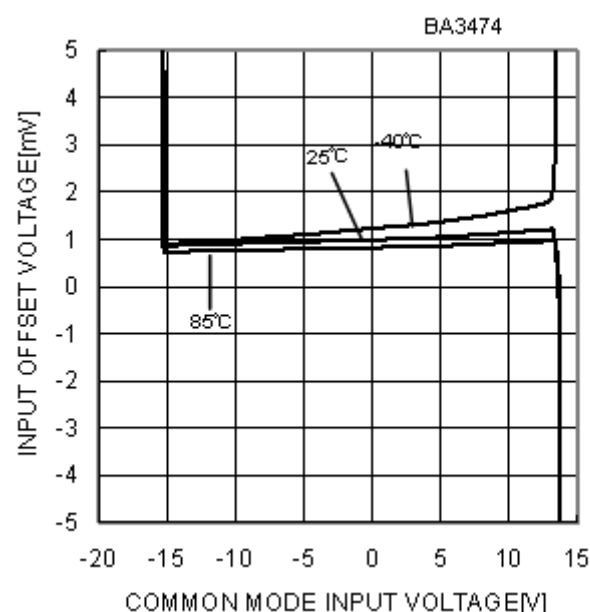


Fig.34
Input Offset Voltage
- Common Mode Input Voltage
(VCC/VEE=15[V]/-15[V])

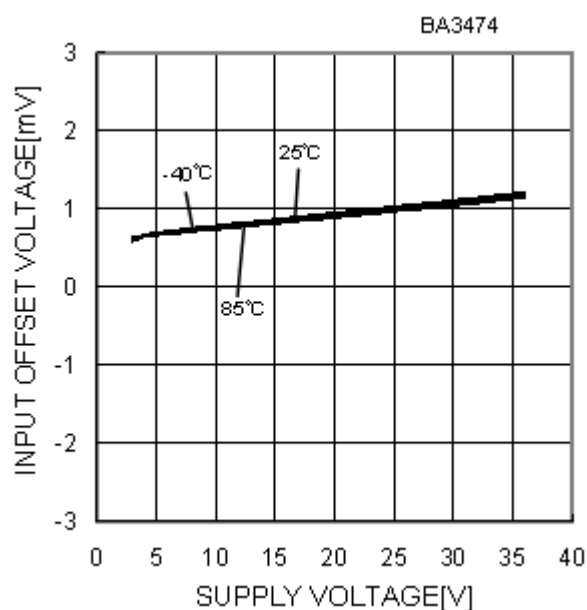


Fig.35
Input Offset Voltage - Supply voltage

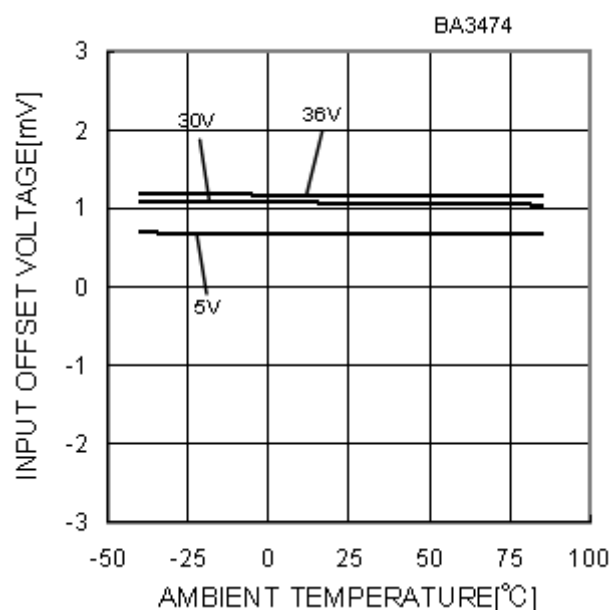


Fig.36
Input Offset Voltage - Ambient Temperature

(*)The data above is ability value of sample, it is not guaranteed

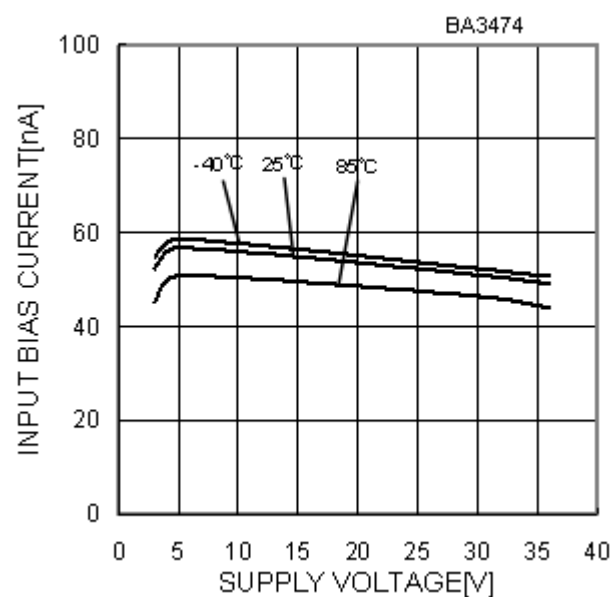


Fig.37
Input Bias Current - Supply voltage

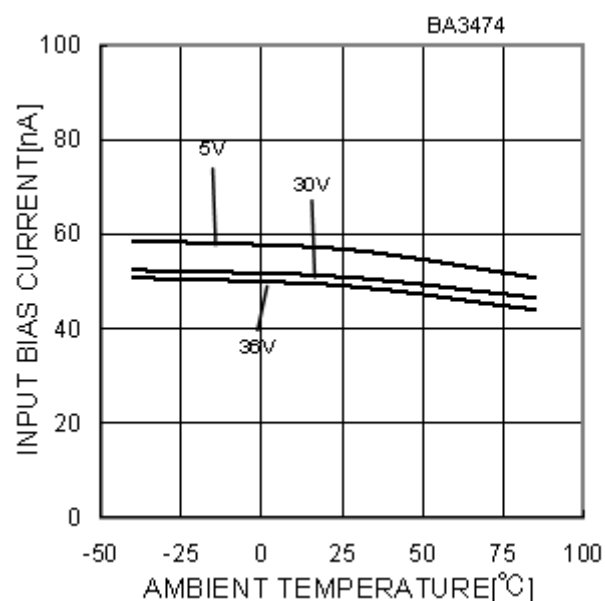


Fig.38
Input Bias Current - Ambient Temperature

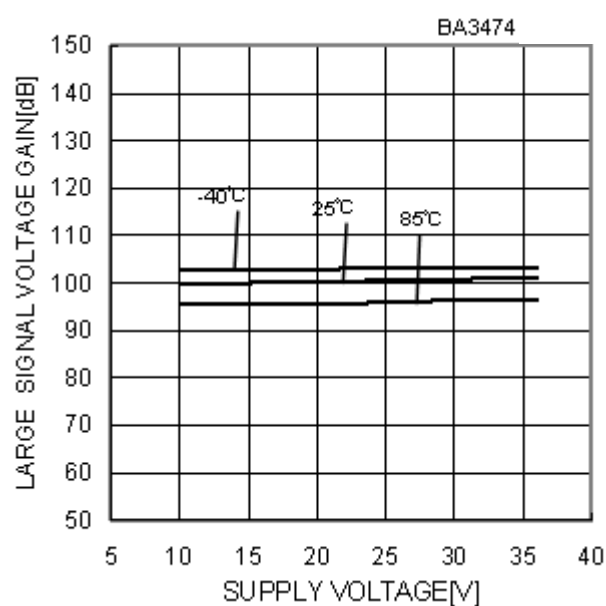


Fig.39
Large Signal Voltage Gain
-Supply Voltage

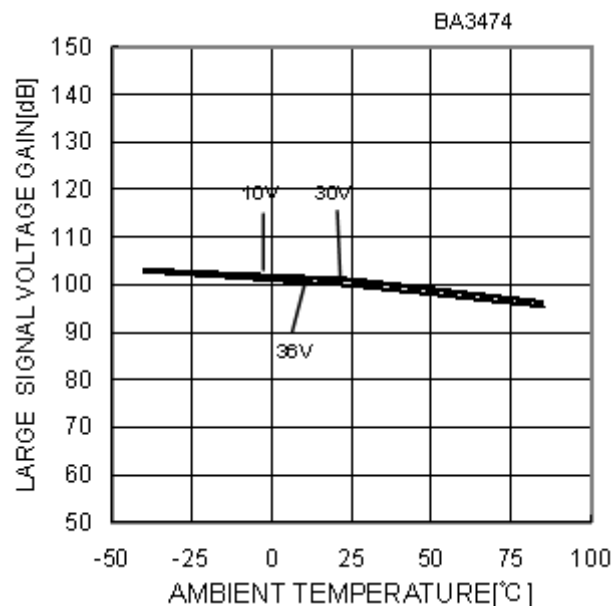


Fig.40
Large Signal Voltage Gain
-Ambient Temperature

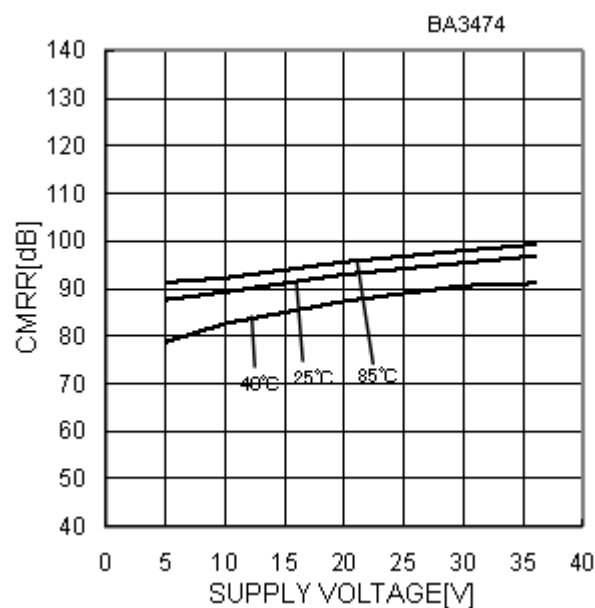


Fig.41
Common Mode Rejection Ratio
-Supply Voltage

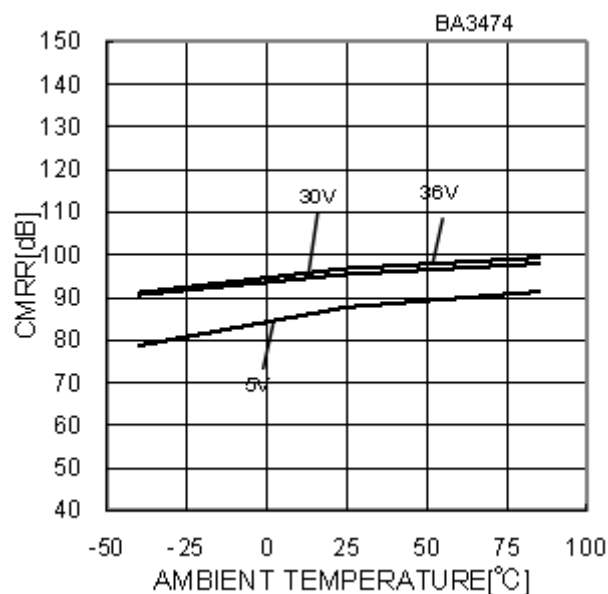


Fig.42
Common Mode Rejection Ratio
-Ambient Temperature

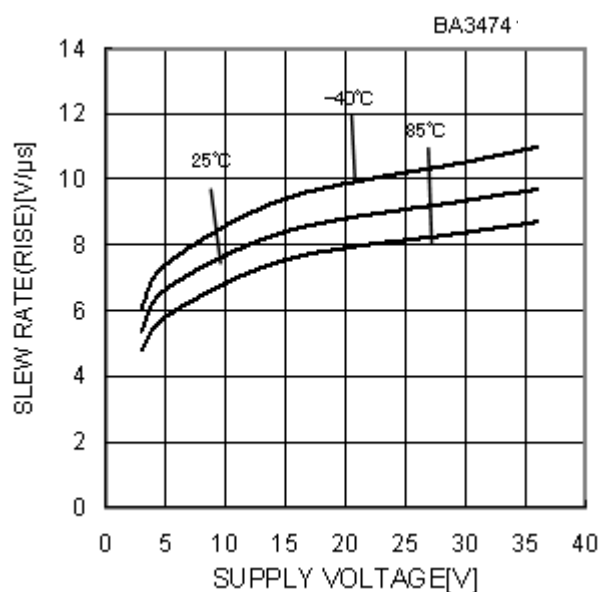


Fig.43
Slew Rate L-H - Supply Voltage
($R_L=10[k\Omega]$)

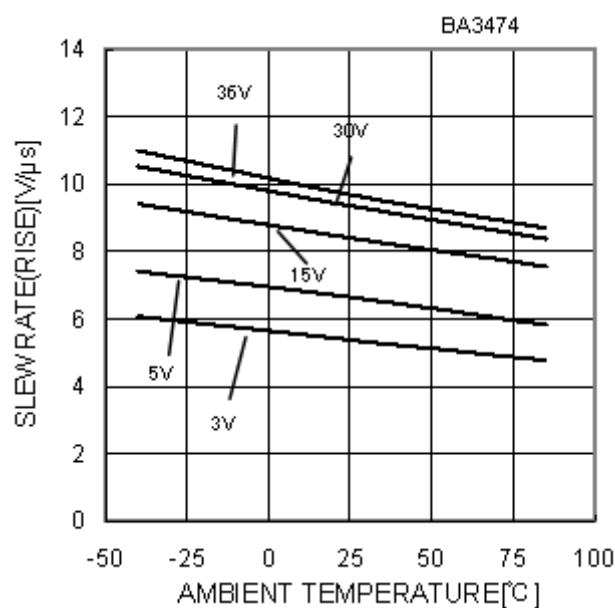


Fig.44
Slew Rate L-H - Ambient Temperature
($R_L=10[k\Omega]$)

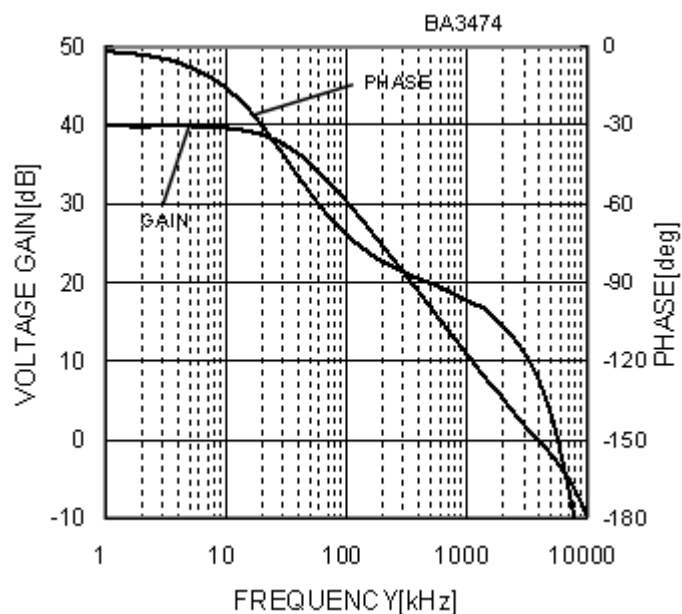


Fig.45
Voltage Gain - Frequency
($V_{CC}=7.5[V]$ / $-7.5[V]$, $A_v=40[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

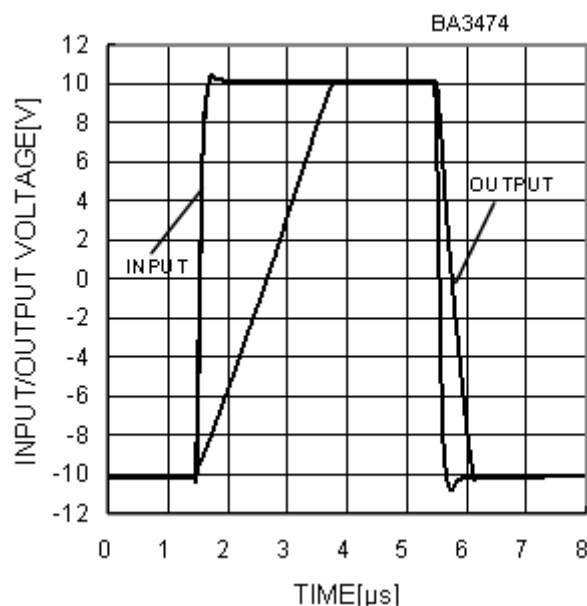


Fig.46
Input / Output Voltage - Time
($V_{CC}/V_{EE}=15[V]$ / $-15[V]$, $A_v=0[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

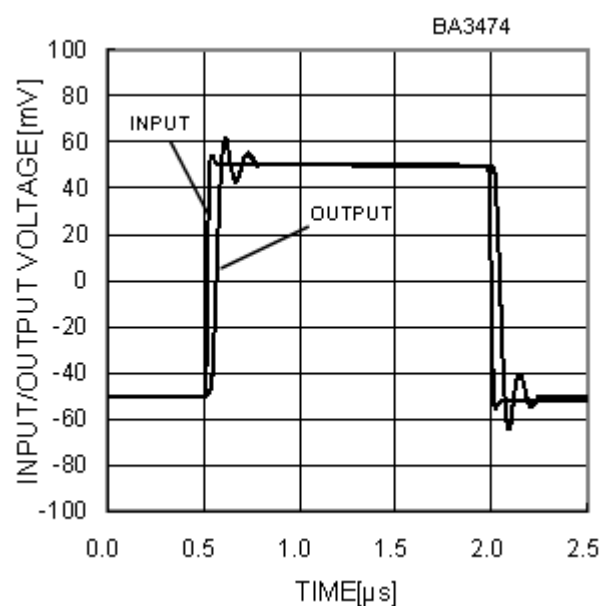


Fig.47
Input / Output Voltage - Time
($V_{CC}/V_{EE}=15[V]$ / $-15[V]$, $A_v=0[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

(*)The data above is ability value of sample, it is not guaranteed.

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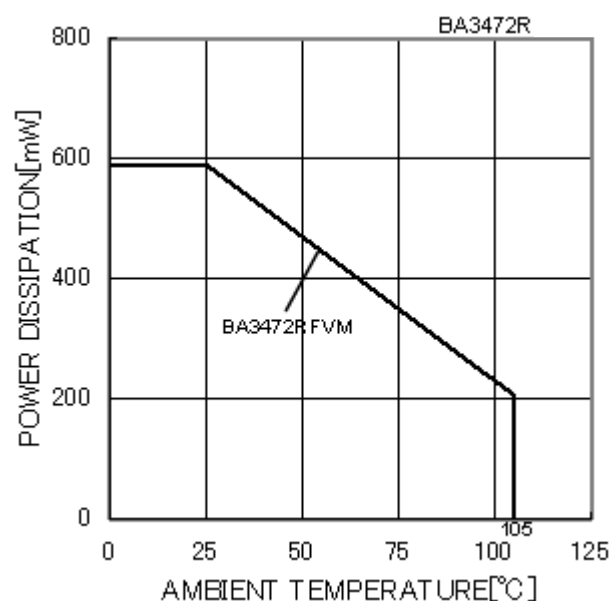


Fig.48
Derating Curve

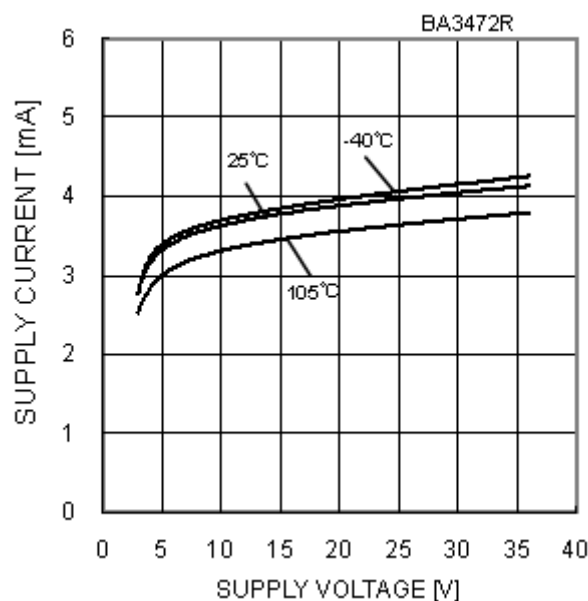


Fig.49
Supply Current - Supply Voltage

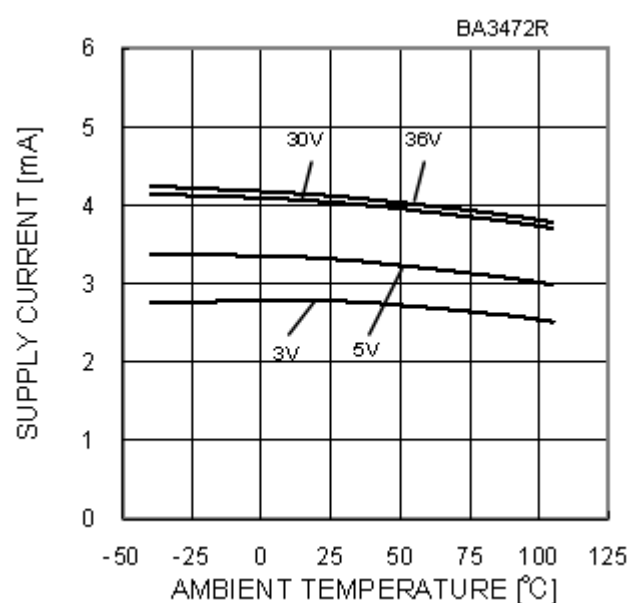


Fig.50
Supply Current - Ambient
Temperature

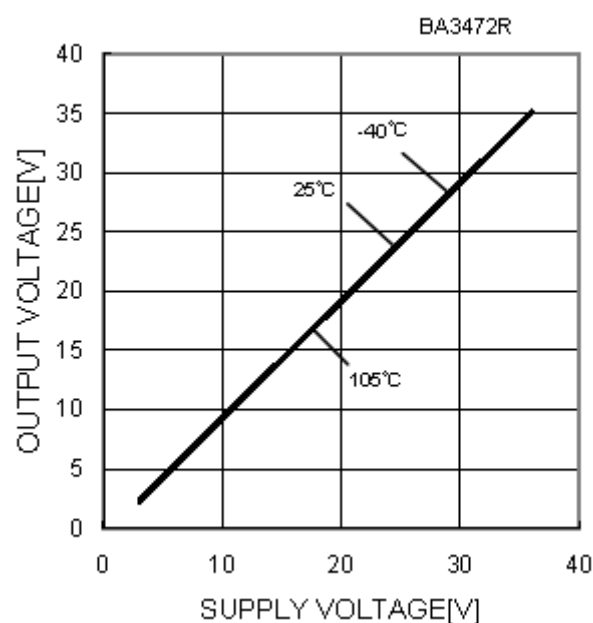


Fig.51
High level Output Voltage
- Supply Voltage
($R_L=10[k\Omega]$)

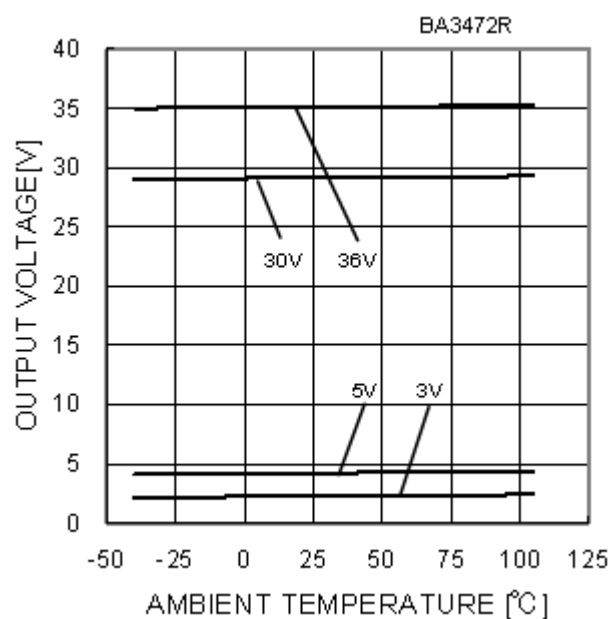


Fig.52
High level Output Voltage
- Ambient Temperature
($R_L=10[k\Omega]$)

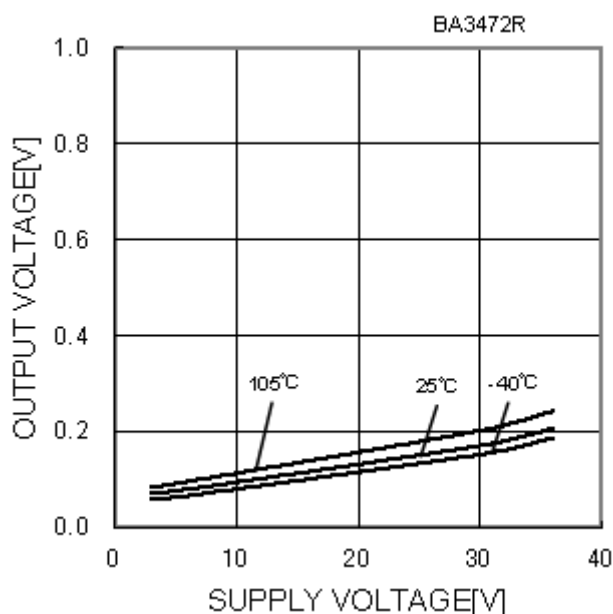


Fig.53
Low level Output Voltage
- Supply Voltage
($R_L=10[k\Omega]$)

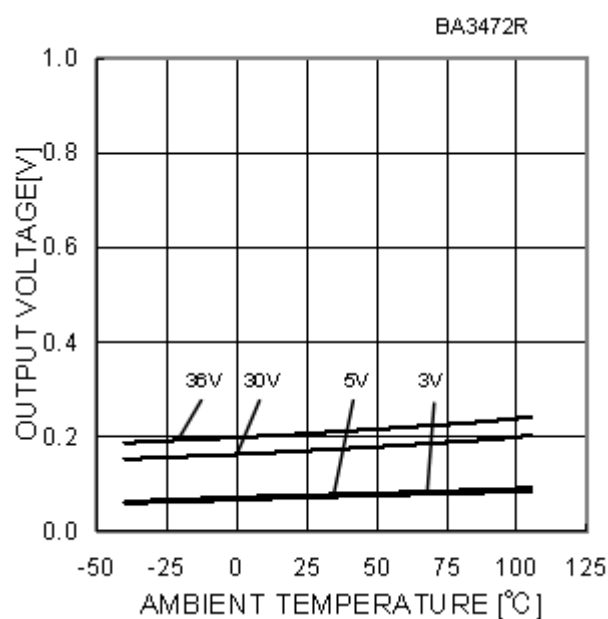


Fig.54
Low level Output Voltage
- Ambient Temperature
($R_L=10[k\Omega]$)

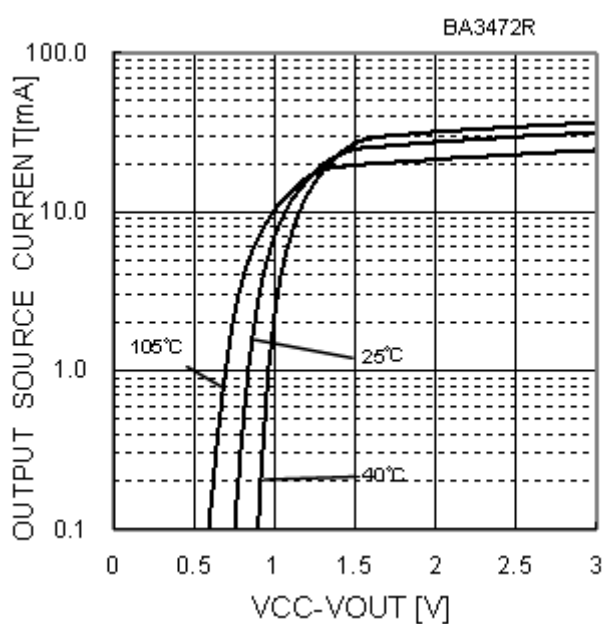


Fig.55
Output Source Current - ($V_{CC}-V_{OUT}$)
($V_{CC}/V_{EE}=5[V]/0[V]$)

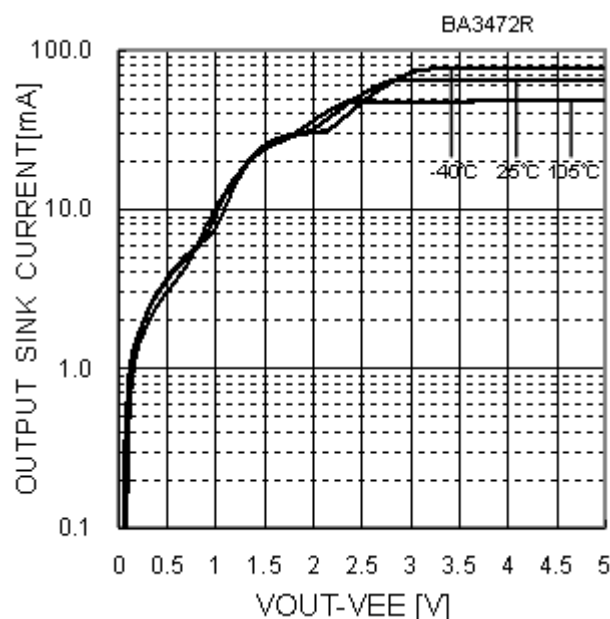


Fig.56
Output Sink Current -
(VOUT-VEE)
(VCC/VEE=5[V]/0[V])

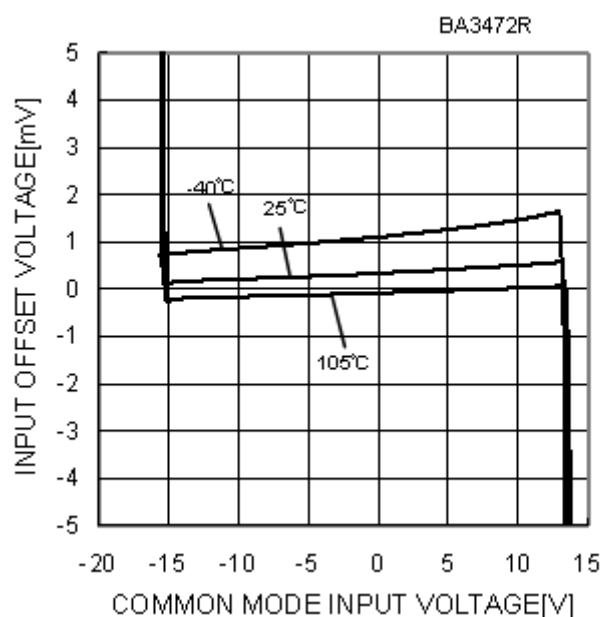


Fig.57
Input Offset Voltage
- Common Mode Input Voltage
(VCC/VEE=15[V]/-15[V])

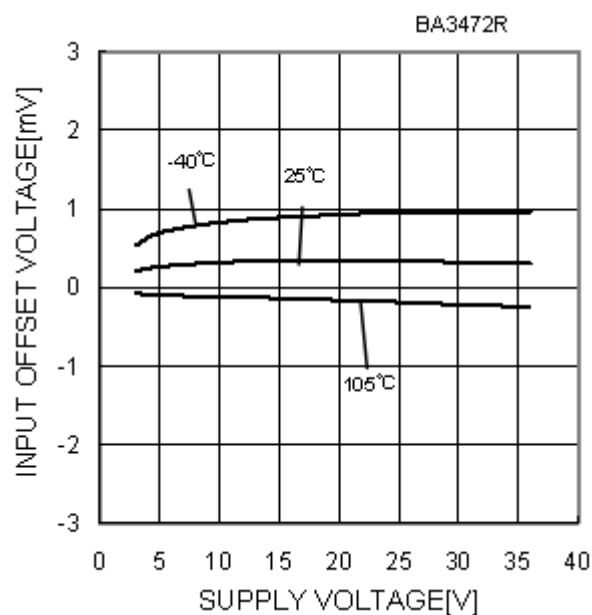


Fig.58
Input Offset Voltage - Supply voltage

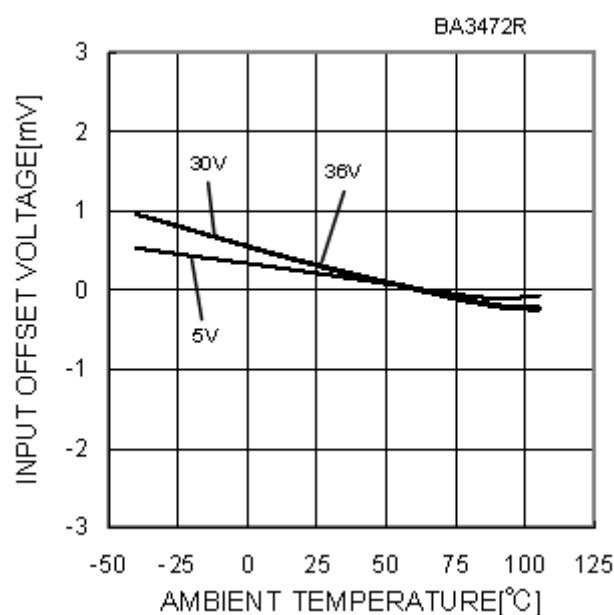


Fig.59
Input Offset Voltage - Ambient
Temperature

(*)The data above is ability value of sample, it is not guaranteed.

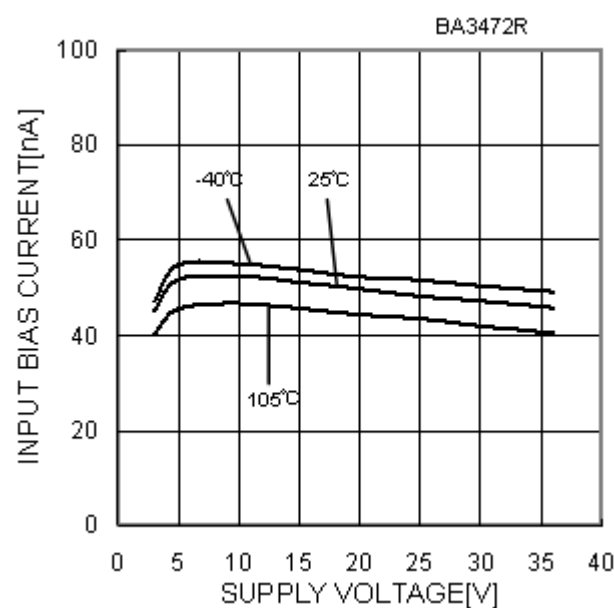


Fig.60
Input Bias Current - Supply
voltage

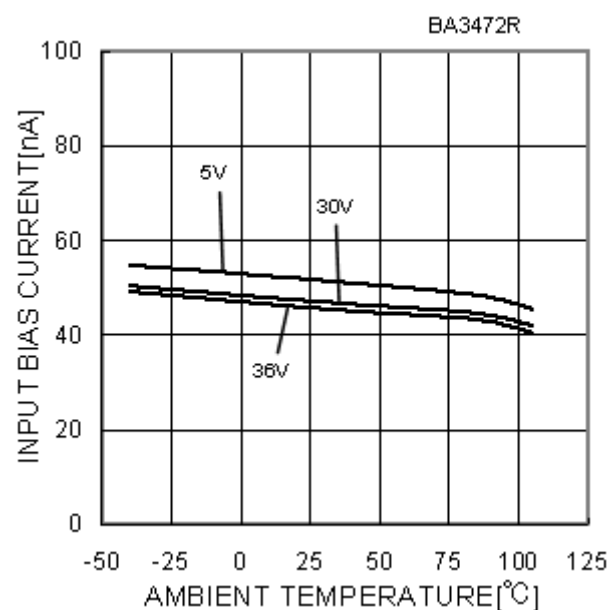


Fig.61
Input Bias Current - Ambient
Temperature

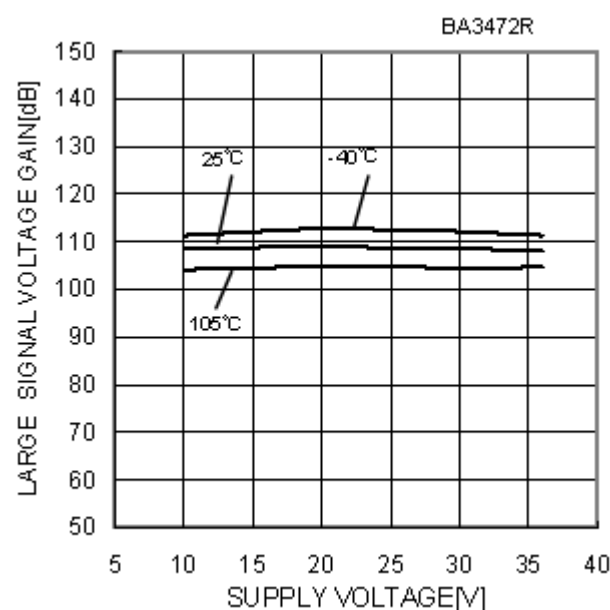


Fig.62
Large Signal Voltage Gain
-Supply Voltage

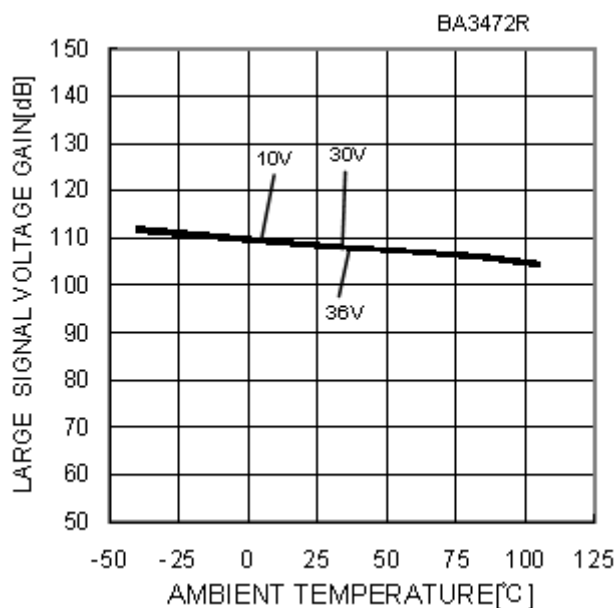


Fig.63
Large Signal Voltage Gain
-Ambient Temperature

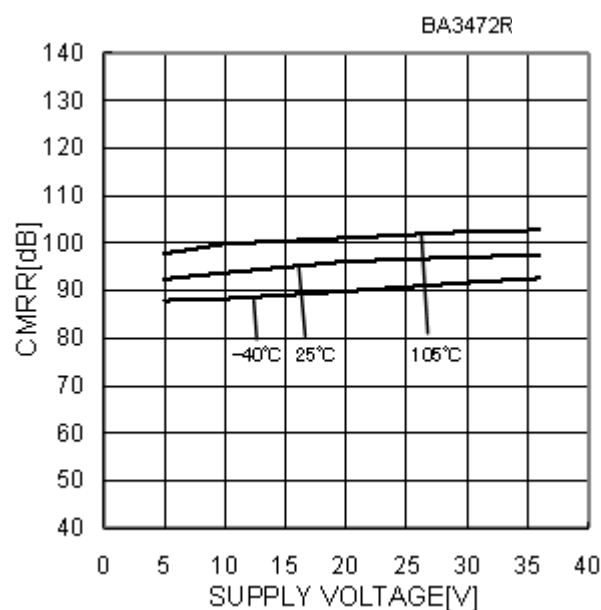


Fig.64
Common Mode Rejection Ratio
-Supply Voltage

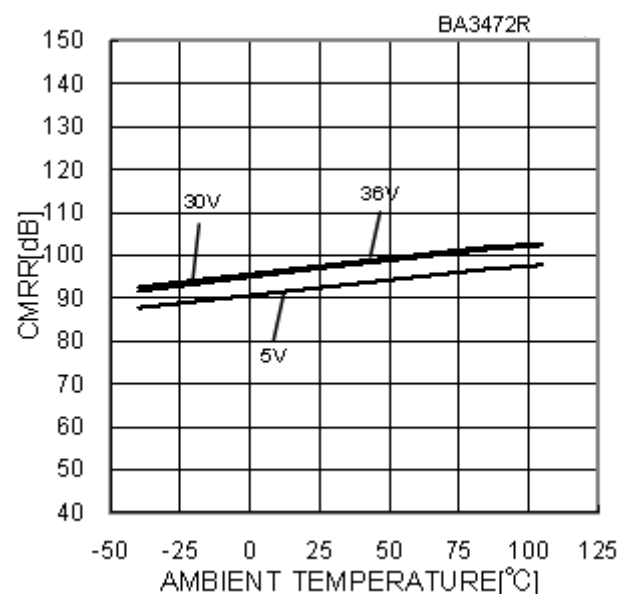


Fig.65
Common Mode Rejection Ratio
-Ambient Temperature

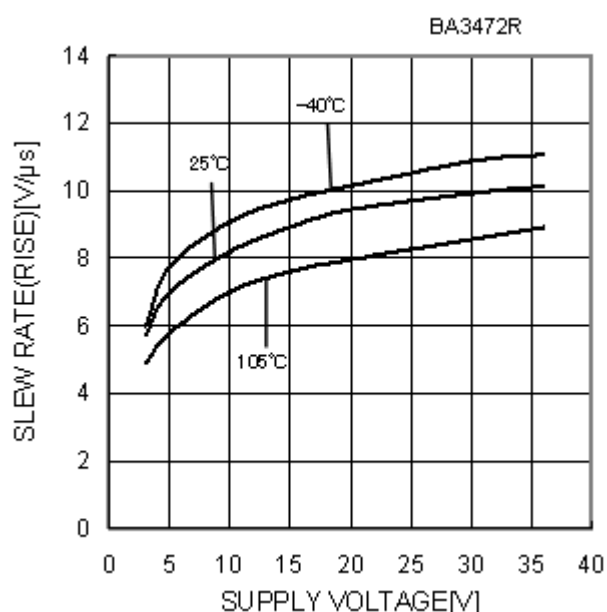


Fig.66
Slew Rate L-H - Supply Voltage
($R_L=10[k\Omega]$)

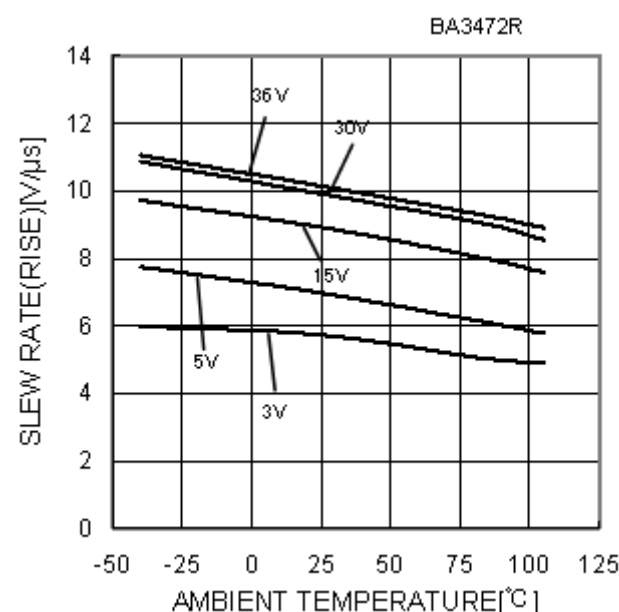


Fig.67
Slew Rate L-H - Ambient Temperature
($R_L=10[k\Omega]$)

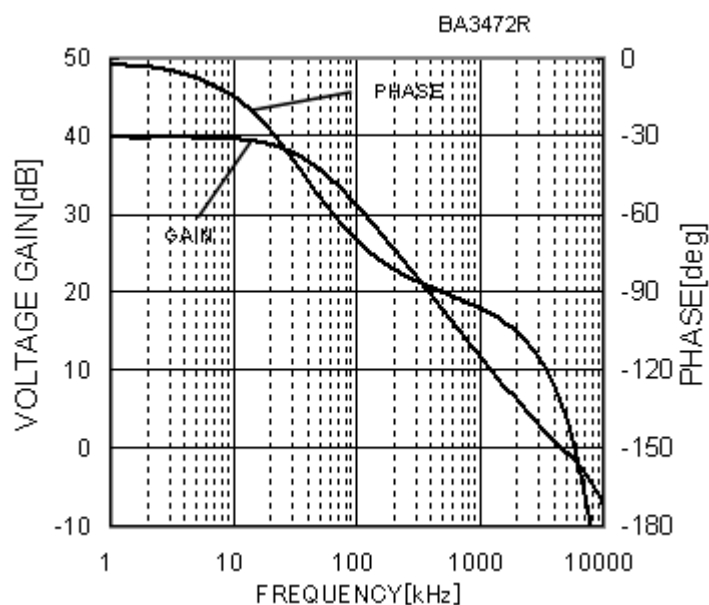


Fig.68
Voltage Gain - Frequency
($V_{CC}=7.5[V]$ / $-7.5[V]$, $A_v=40[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

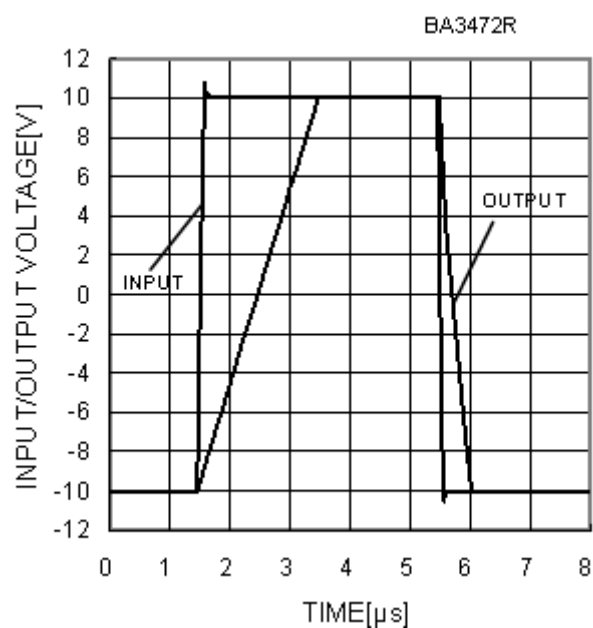


Fig.69
Input / Output Voltage - Time
($V_{CC}/V_{EE}=15[V]$ / $-15[V]$, $A_v=0[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

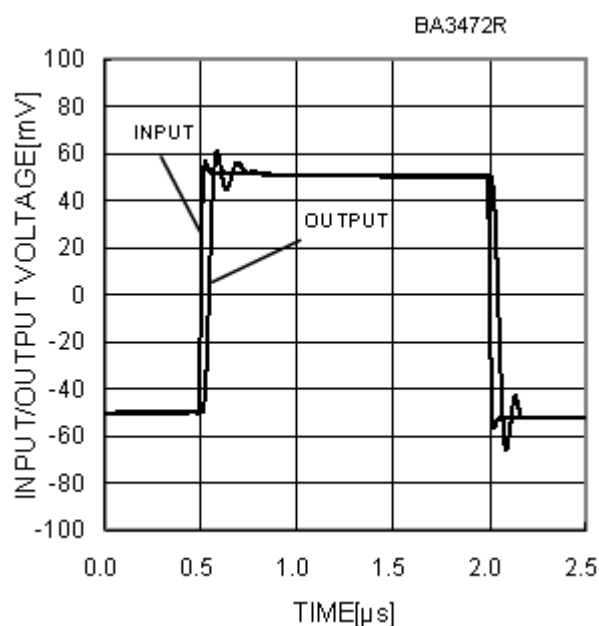


Fig.70
Input / Output Voltage - Time
($V_{CC}/V_{EE}=15[V]$ / $-15[V]$, $A_v=0[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

(*) The data above is ability value of sample, it is not guaranteed.

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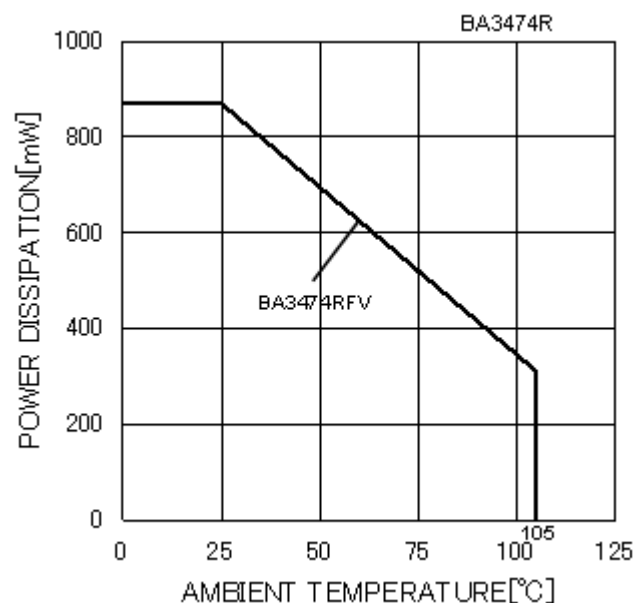


Fig.71
Derating Curve

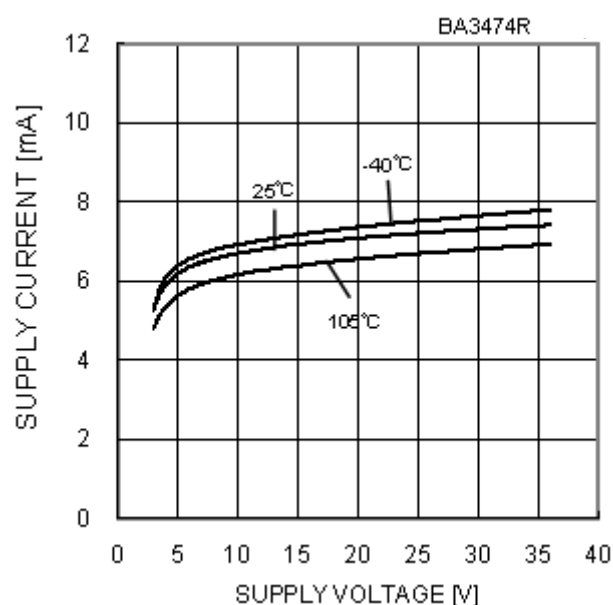


Fig.72
Supply Current - Supply Voltage

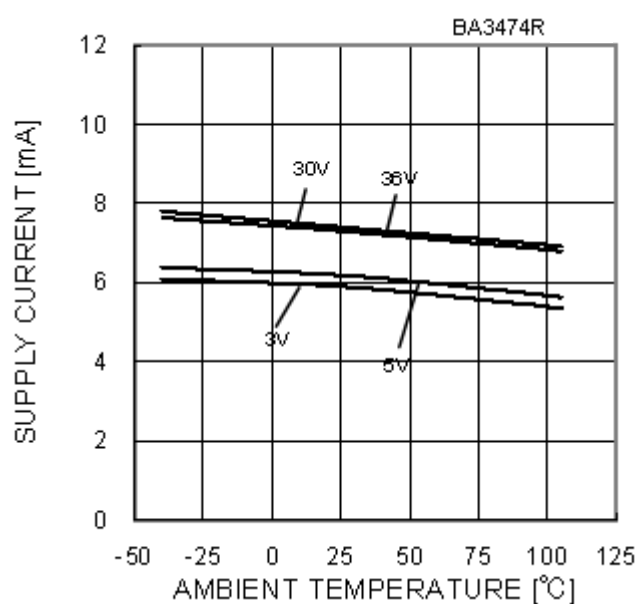


Fig.73
Supply Current - Ambient Temperature

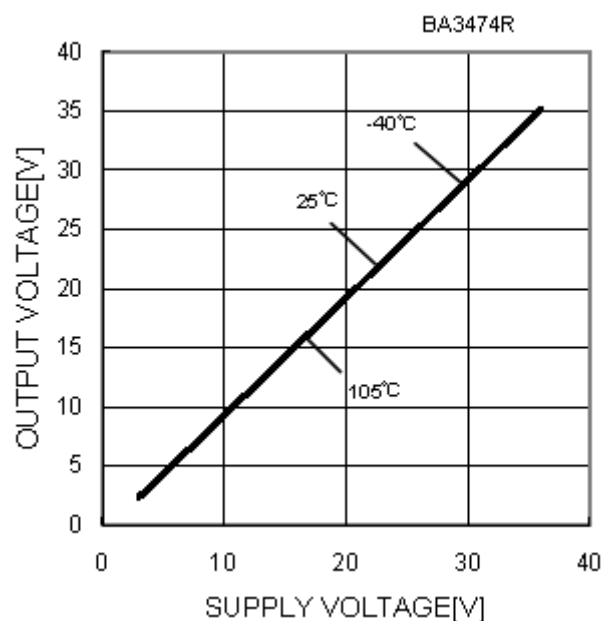


Fig.74
High level Output Voltage
- Supply Voltage
($R_L=10[k\Omega]$)

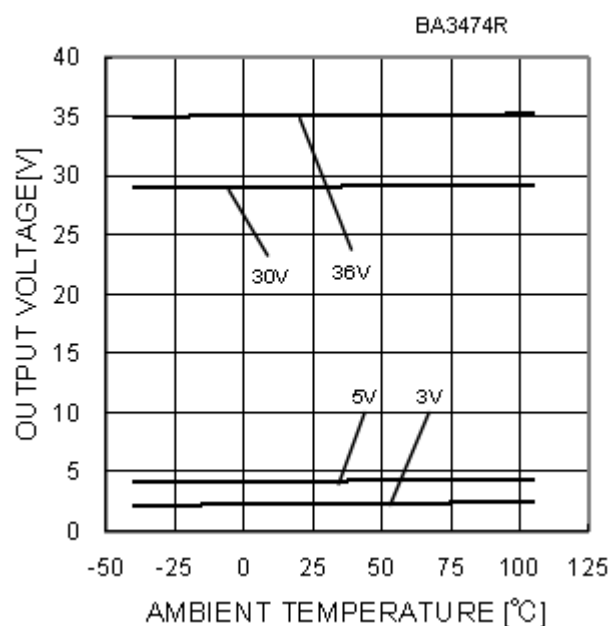


Fig.75
High level Output Voltage
- Ambient Temperature
($R_L=10[k\Omega]$)

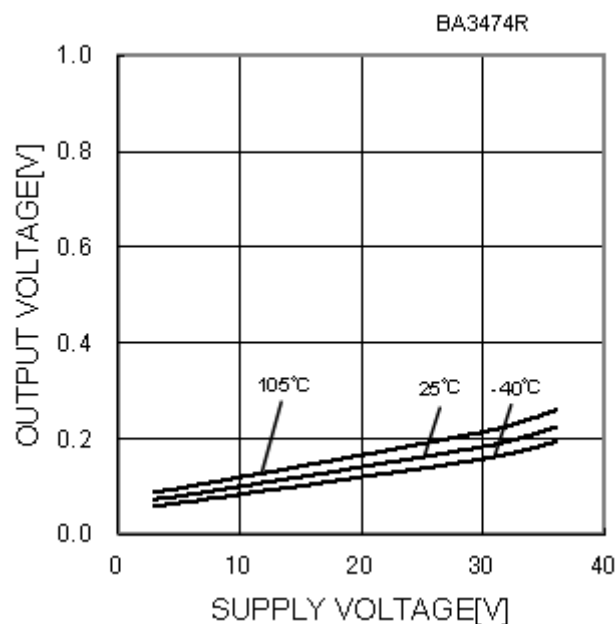


Fig.76
Low level Output Voltage
- Supply Voltage
($R_L=10[k\Omega]$)

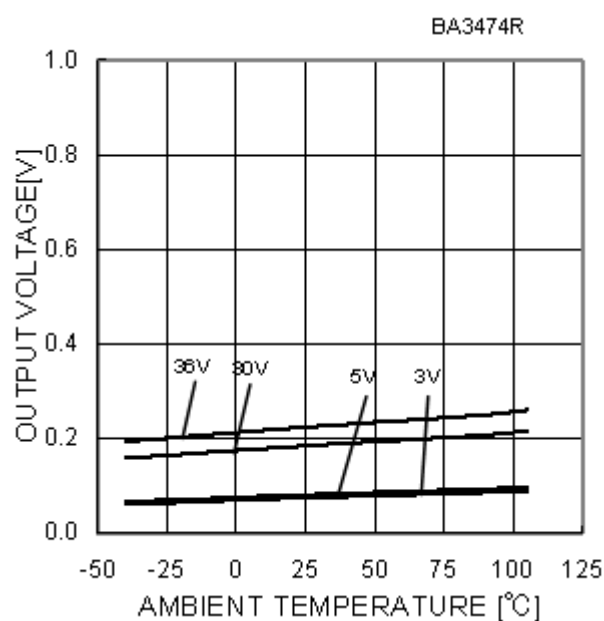


Fig.77
Low level Output Voltage
- Ambient Temperature
($R_L=10[k\Omega]$)

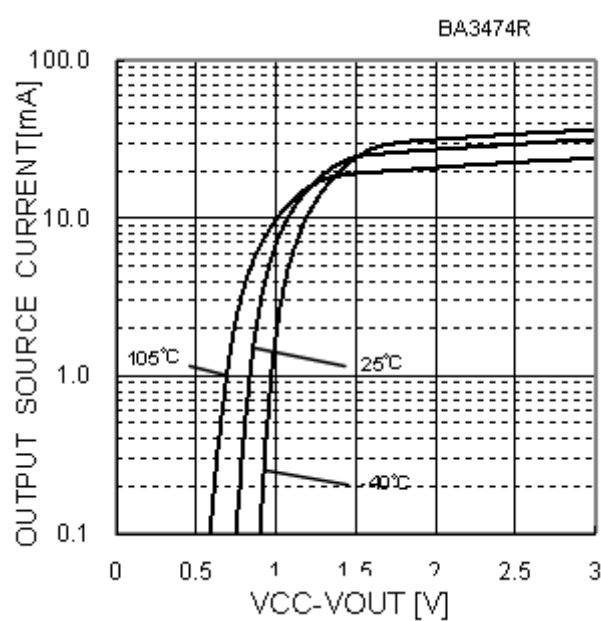


Fig.78
Output Source Current - ($V_{CC}-V_{OUT}$)
($V_{CC}/V_{EE}=5[V]/0[V]$)

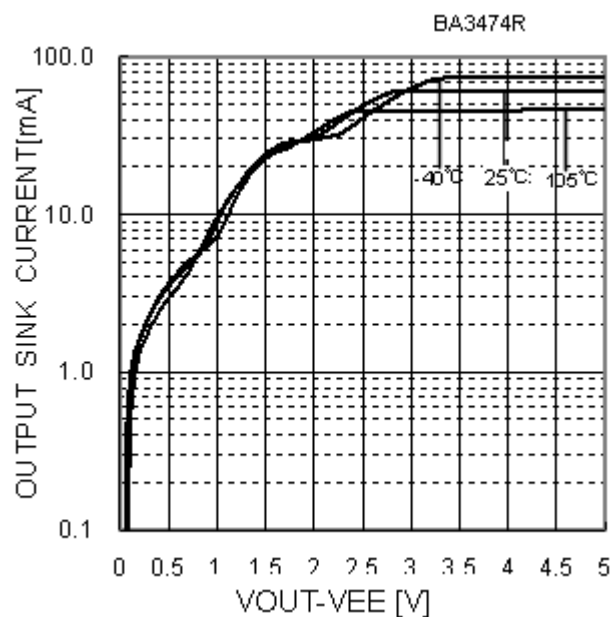


Fig.79
Output Sink Current - (VOUT-VEE)
(VCC/VEE=5[V]/0[V])

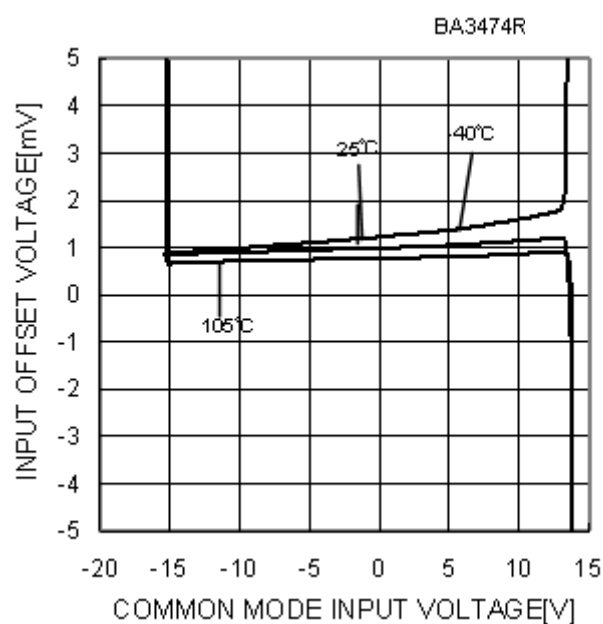


Fig.80
Input Offset Voltage
- Common Mode Input Voltage
(VCC/VEE=15[V]/-15[V])

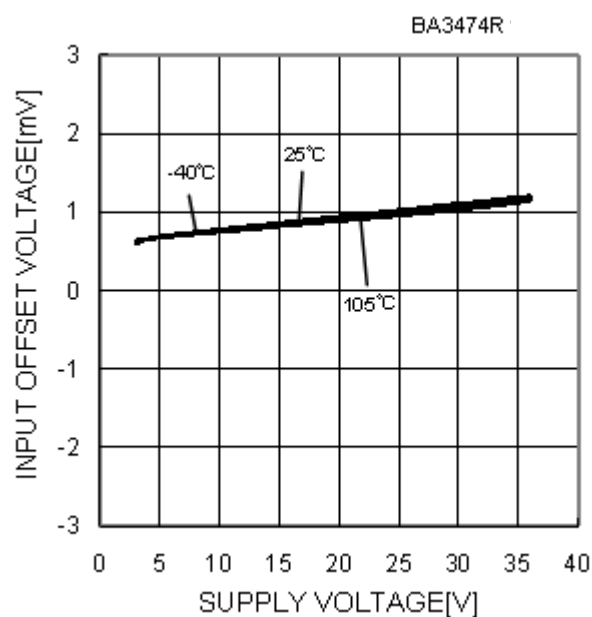


Fig.81
Input Offset Voltage - Supply voltage

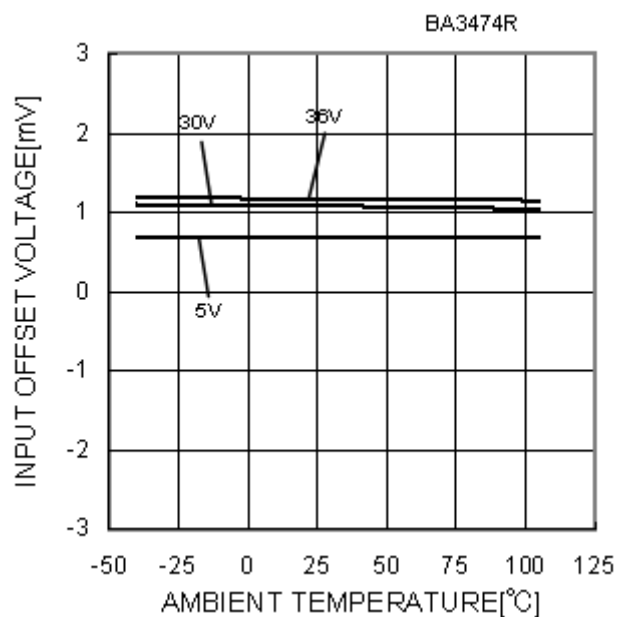


Fig.82
Input Offset Voltage - Ambient Temperature

(*)The data above is ability value of sample, it is not guaranteed

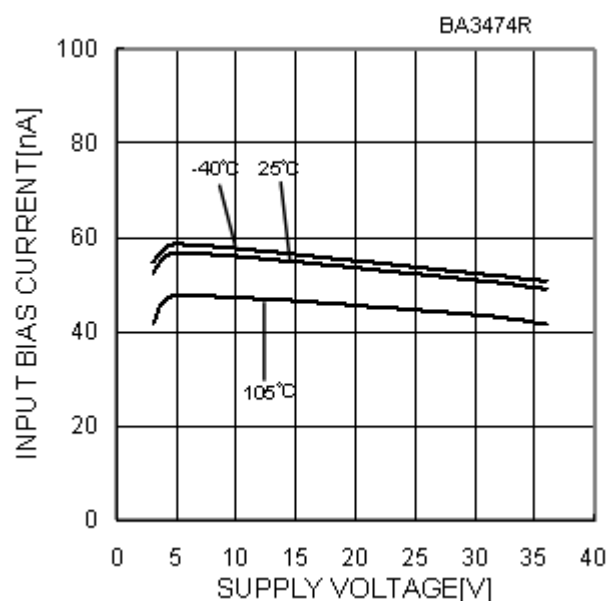


Fig.83
Input Bias Current - Supply voltage

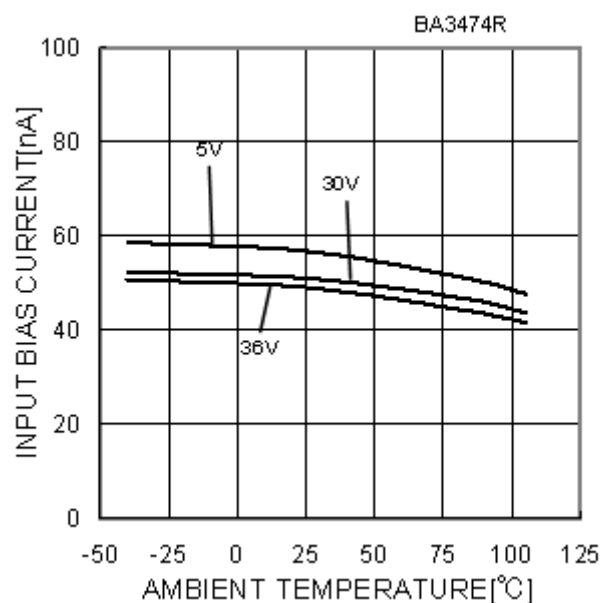


Fig.84
Input Bias Current - Ambient Temperature

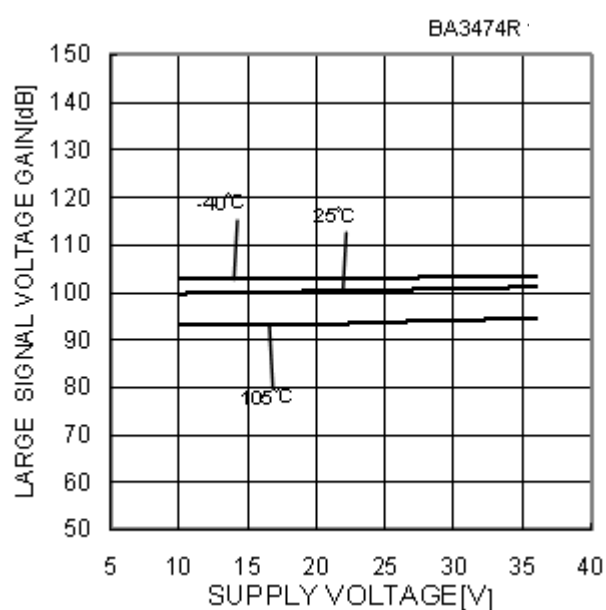


Fig.85
Large Signal Voltage Gain
-Supply Voltage

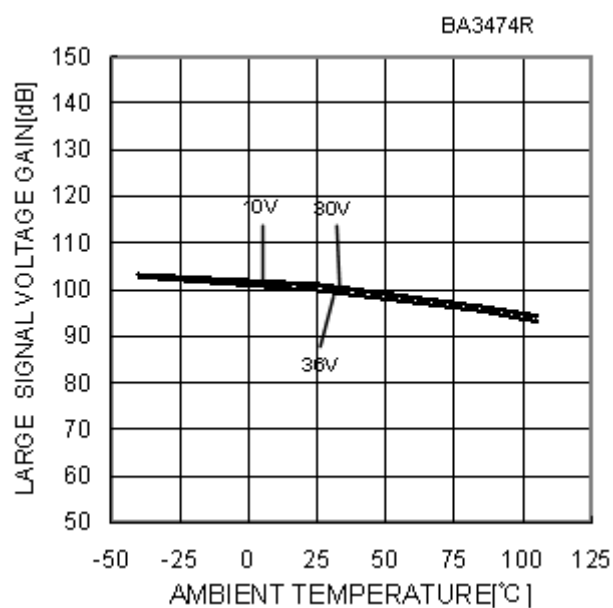


Fig.86
Large Signal Voltage Gain
-Ambient Temperature

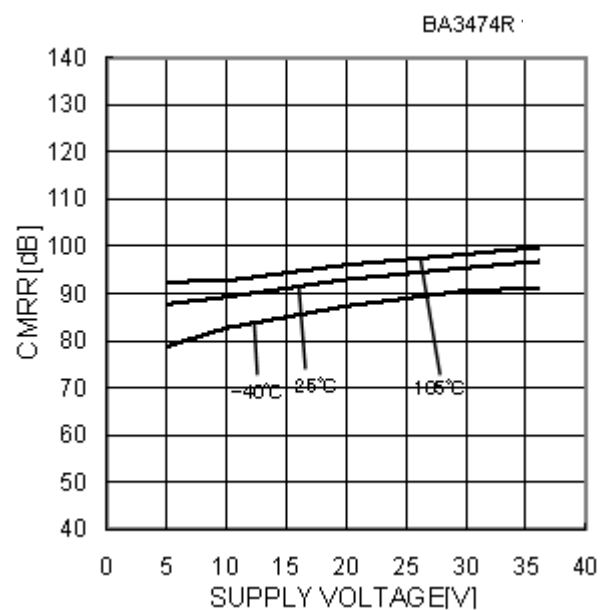


Fig.87
Common Mode Rejection Ratio
-Supply Voltage

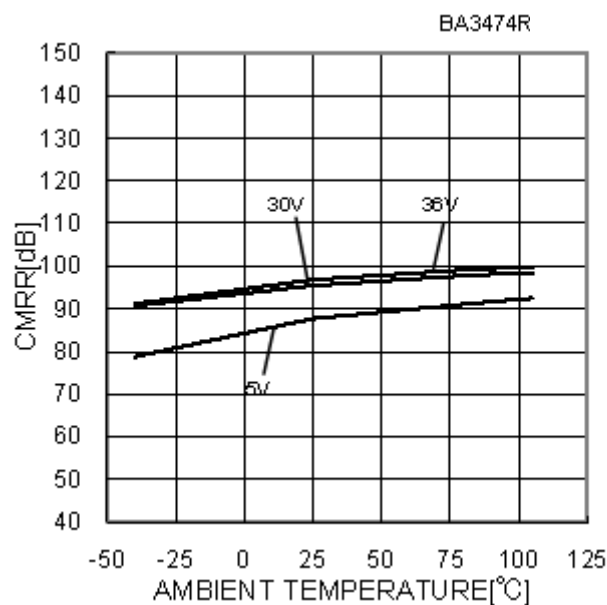


Fig.88
Common Mode Rejection Ratio
-Ambient Temperature

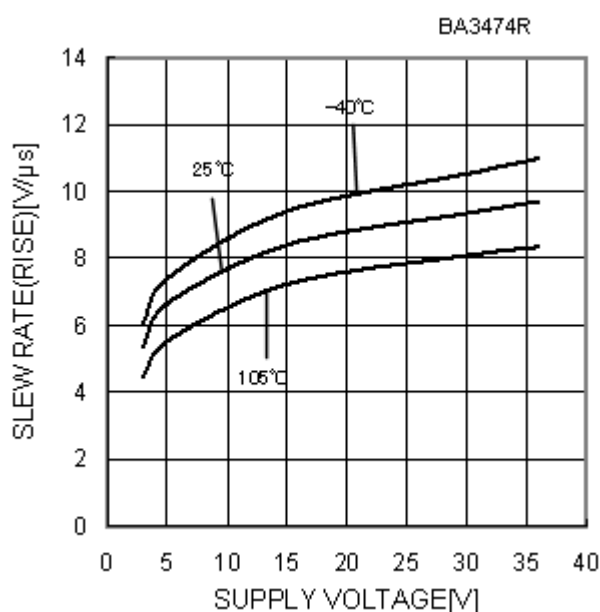


Fig.89
Slew Rate L-H - Supply Voltage
($R_L=10[k\Omega]$)

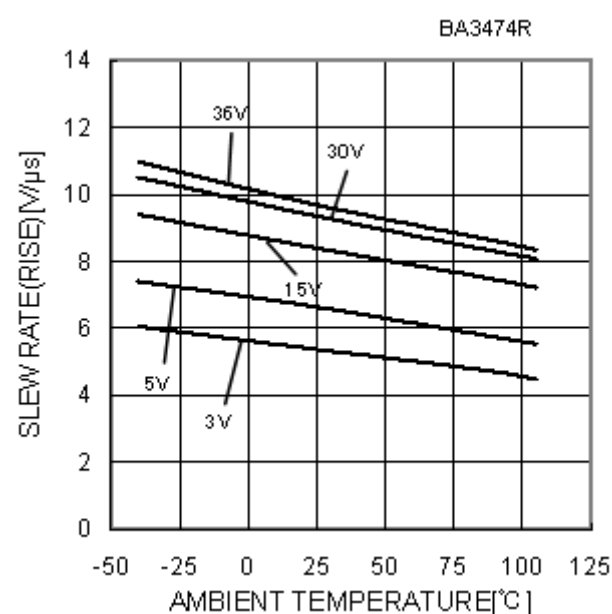


Fig.90
Slew Rate L-H - Ambient Temperature
($R_L=10[k\Omega]$)

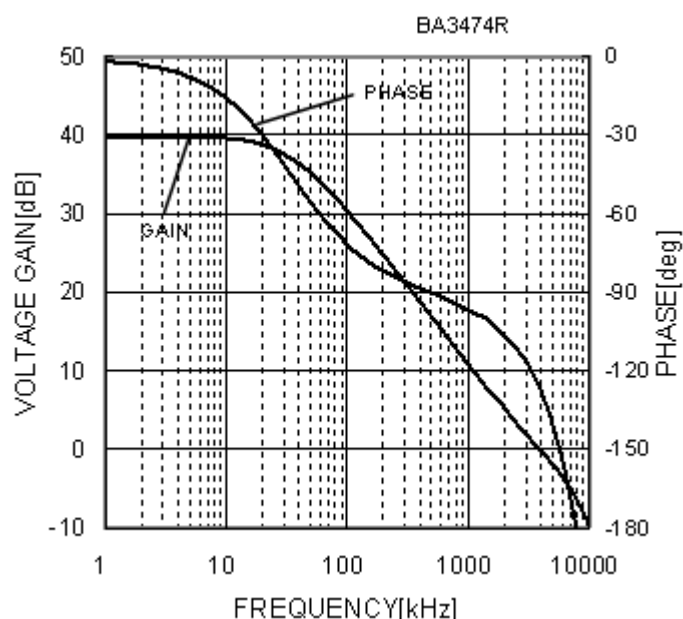


Fig.91
Voltage Gain - Frequency
($V_{CC}=7.5[V]$, $V_{EE}=-7.5[V]$, $A_v=40[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

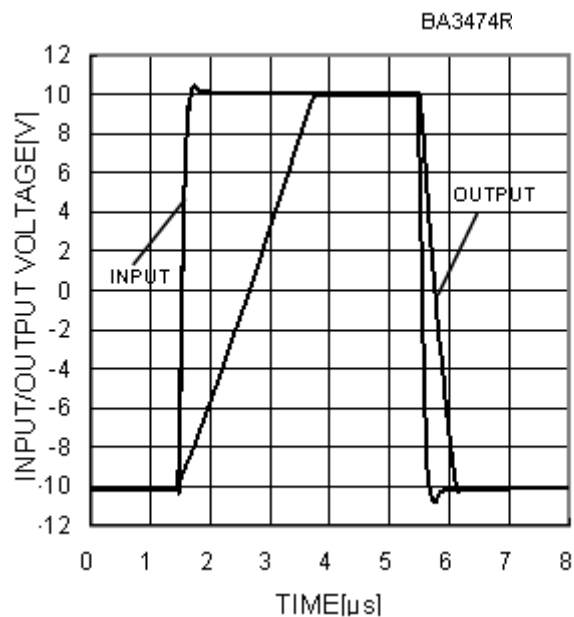


Fig.92
Input / Output Voltage - Time
($V_{CC}/V_{EE}=15[V]/-15[V]$, $A_v=0[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

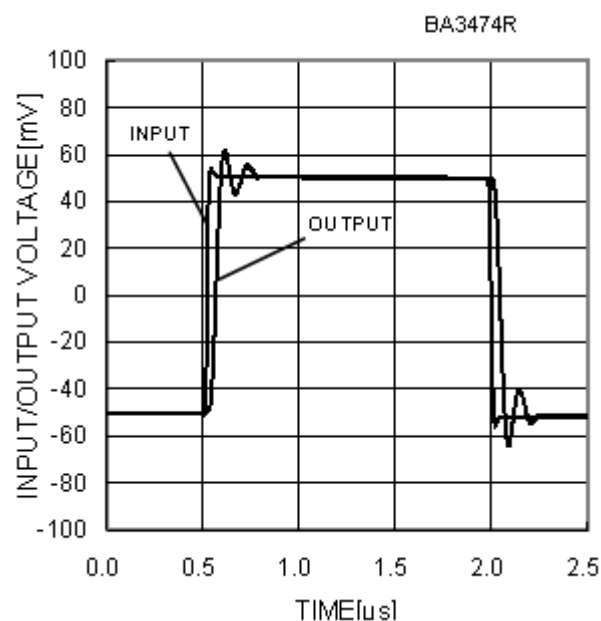


Fig.93
Input / Output Voltage - Time
($V_{CC}/V_{EE}=15[V]/-15[V]$, $A_v=0[dB]$,
 $R_L=2[k\Omega]$, $C_L=100[pF]$, $T_a=25[^\circ C]$)

(*)The data above is ability value of sample, it is not guaranteed

● Application Information

Test circuit 1 NULL method

VCC, VEE, EK, Vicm Unit : [V]

Parameter	VF	S1	S2	S3	VCC	VEE	EK	Vicm	Calculation
Input Offset Voltage	VF1	ON	ON	OFF	15	-15	0	0	1
Input Offset Current	VF2	OFF	OFF	OFF	15	-15	0	0	2
Input Bias Current	VF3	OFF	ON	OFF	15	-15	0	0	3
	VF4	ON	OFF						
Large Signal Voltage Gain	VF5	ON	ON	ON	15	-15	+10	0	4
	VF6				15	-15	-10	0	
Common-mode Rejection Ratio (Input Common-mode Voltage Range)	VF7	ON	ON	OFF	15	-15	0	-15	5
	VF8				15	-15	0	13	
Power Supply Rejection Ratio	VF9	ON	ON	OFF	2	-2	0	0	6
	VF10				18	-18	0	0	

—Calculation—

1. Input Offset Voltage (Vio)

$$V_{io} = \frac{|VF1|}{1 + R_f / R_s} \quad [V]$$

2. Input Offset Current (Iio)

$$I_{io} = \frac{|VF2 - VF1|}{R_i \times (1 + R_f / R_s)} \quad [A]$$

3. Input Bias Current (Ib)

$$I_b = \frac{|VF4 - VF3|}{2 \times R_i \times (1 + R_f / R_s)} \quad [A]$$

4. Large Signal Voltage Gain (Av)

$$A_v = 20 \times \log \frac{\Delta E_k \times (1 + R_f / R_s)}{|VF5 - VF6|} \quad [dB]$$

5. Common-mode Rejection Ratio (CMRR)

$$CMRR = 20 \times \log \frac{\Delta V_{icm} \times (1 + R_f / R_s)}{|VF8 - VF7|} \quad [dB]$$

6. Power Supply Rejection Ratio (PSRR)

$$PSRR = 20 \times \log \frac{\Delta V_{cc} \times (1 + R_f / R_s)}{|VF10 - VF9|} \quad [dB]$$

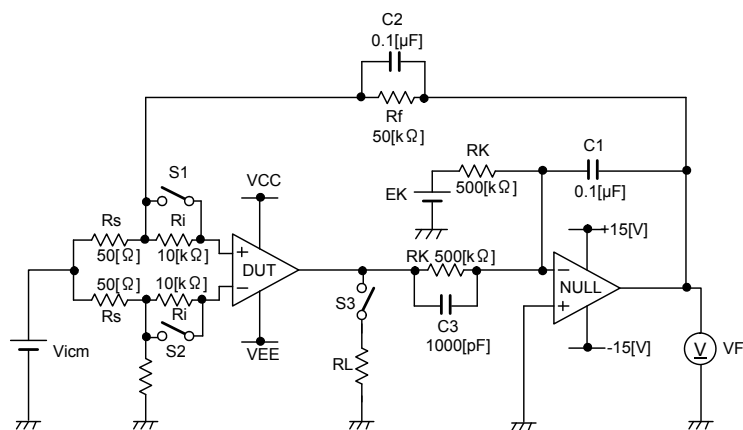


Fig.94 Test circuit 1 (one channel only)

Test circuit2 switch condition

SW No.	SW 1	SW 2	SW 3	SW 4	SW 5	SW 6	SW 7	SW 8	SW 9	SW 10	SW 11	SW 12	SW 13	SW 14
Supply Current	OFF	OFF	OFF	ON	OFF	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF	OFF
High Level Output Voltage	OFF	OFF	ON	OFF	OFF	ON	OFF	OFF	ON	OFF	OFF	OFF	ON	OFF
Low Level Output Voltage	OFF	OFF	ON	OFF	OFF	ON	OFF	OFF	OFF	OFF	OFF	OFF	ON	OFF
Output Source Current	OFF	OFF	ON	OFF	OFF	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF	ON
Output Sink Current	OFF	OFF	ON	OFF	OFF	ON	OFF	OFF	OFF	OFF	OFF	OFF	OFF	ON
Slew Rate	OFF	OFF	OFF	ON	OFF	OFF	OFF	ON	ON	ON	OFF	OFF	OFF	OFF
Gain Bandwidth Product	OFF	ON	OFF	OFF	ON	ON	OFF	OFF	ON	ON	OFF	OFF	OFF	OFF
Equivalent Input Noise Voltage	ON	OFF	OFF	OFF	ON	ON	OFF	OFF	OFF	OFF	ON	OFF	OFF	OFF

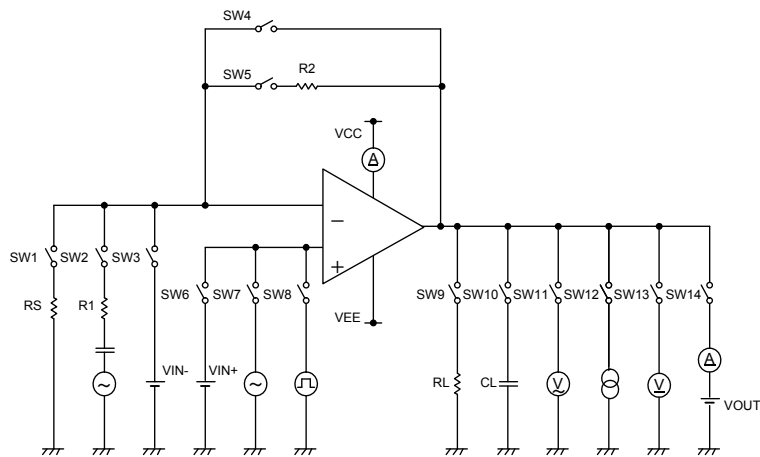


Fig.95 Test circuit 2 (one channel only)

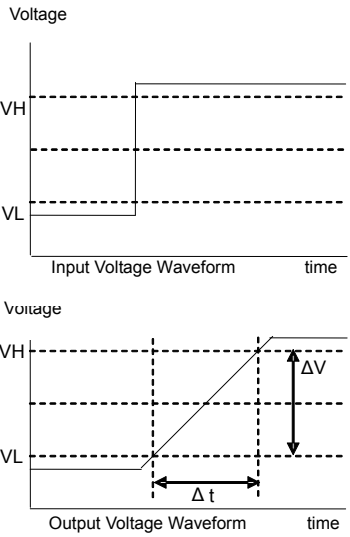


Fig.96 Slew rate input output wave

Test circuit 3 Channel separation

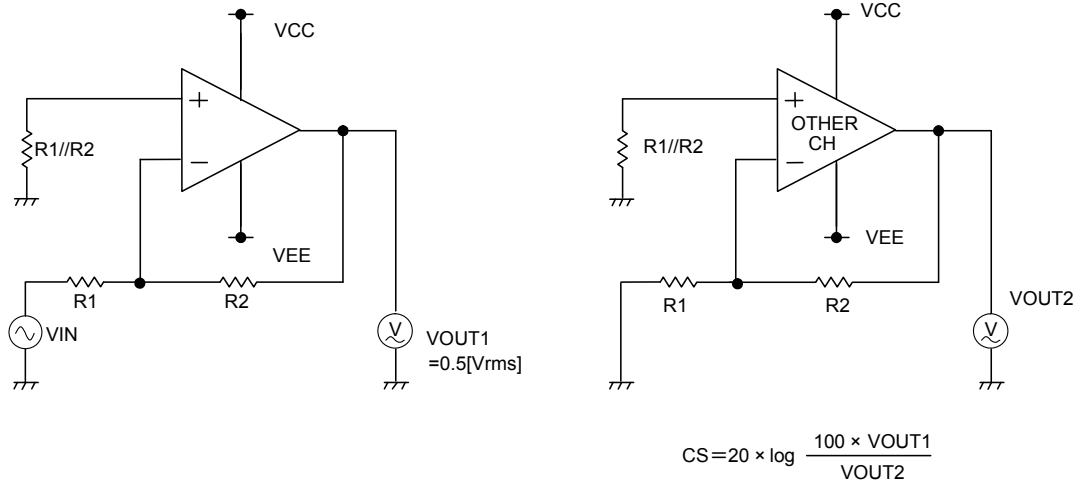


Fig.97 Test circuit 3

Derating curves

Power dissipation (total loss) indicates the power that can be consumed by IC at $T_a=25^{\circ}\text{C}$ (normal temperature). IC is heated when it consumed power, and the temperature of IC chip becomes higher than ambient temperature. The temperature that can be accepted by IC chip depends on circuit configuration, manufacturing process, and consumable power is limited. Power dissipation is determined by the temperature allowed in IC chip (maximum junction temperature) and thermal resistance of package (heat dissipation capability). The maximum junction temperature is typically equal to the maximum value in the storage temperature range. Heat generated by consumed power of IC radiates from the mold resin or lead frame of the package. The parameter which indicates this heat dissipation capability (hardness of heat release) is called thermal resistance, represented by the symbol θ_{ja} [$^{\circ}\text{C}/\text{W}$]. The temperature of IC inside the package can be estimated by this thermal resistance. Fig.98 (a) shows the model of thermal resistance of the package. Thermal resistance θ_{ja} , ambient temperature T_a , junction temperature T_j , and power dissipation P_d can be calculated by the equation below:

$$\theta_{ja} = (T_j - T_a) / P_d \quad [^{\circ}\text{C}/\text{W}] \quad \dots \dots (I)$$

Derating curve in Fig.98 (b) indicates power that can be consumed by IC with reference to ambient temperature. Power that can be consumed by IC begins to attenuate at certain ambient temperature. This gradient is determined by thermal resistance θ_{ja} . Thermal resistance θ_{ja} depends on chip size, power consumption, package, ambient temperature, package condition, wind velocity, etc even when the same of package is used. Thermal reduction curve indicates a reference value measured at a specified condition. Fig.99(c) ~ (f) shows a derating curve for an example of BA3472, BA3474, BA3472R, BA3474R.

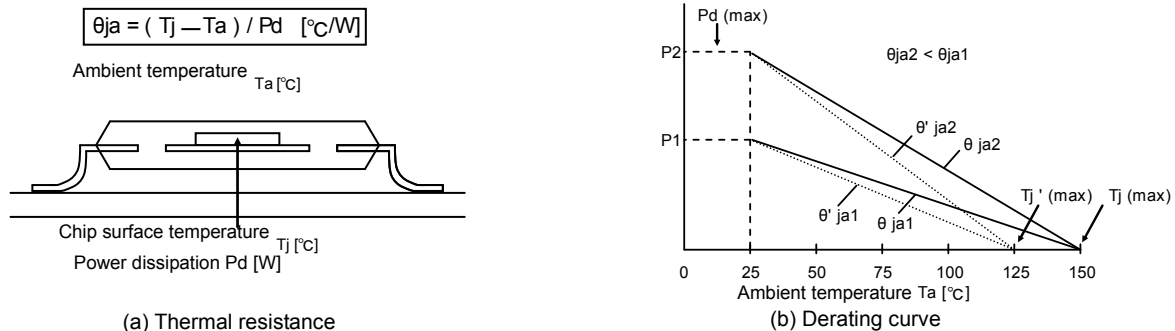
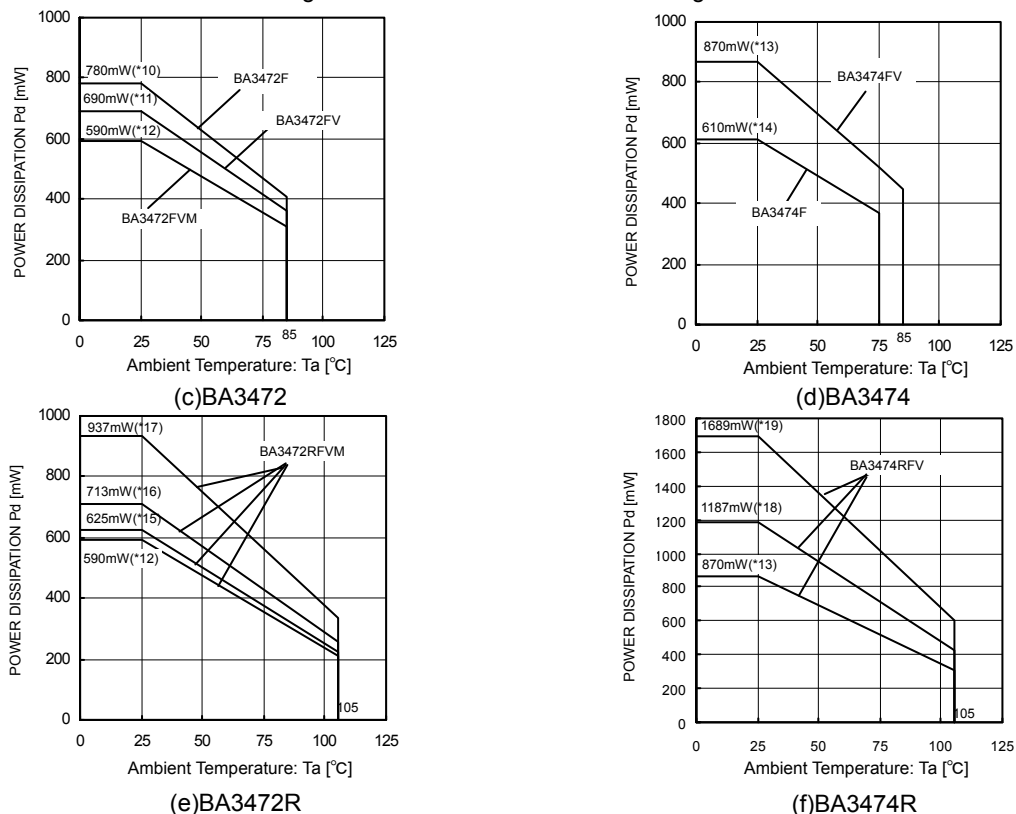


Fig. 98 Thermal resistance and derating curve



(*10)	(*11)	(*12)	(*13)	(*14)	(*15)	(*16)	(*17)	(*18)	(*19)	Unit
6.2	5.5	4.7	7.0	4.9	5.0	5.7	7.5	9.5	13.5	[mW/ $^{\circ}\text{C}$]

When using the unit above $T_a=25^{\circ}\text{C}$, subtract the value above per degree $^{\circ}\text{C}$.

(*10) (*11) (*12) (*13) (*14) Mounted on a glass epoxy 1 layers PCB 70[mm] $\times$ 70[mm] $\times$ 1.6[mm] (occupied copper area : below 3[%]).

(*15) Mounted on a glass epoxy 2 layers PCB 70[mm] $\times$ 70[mm] $\times$ 1.6[mm] (occupied copper area : 15mm $\times$ 15mm).

(*16) (*18) Mounted on a glass epoxy 2 layers PCB 70[mm] $\times$ 70[mm] $\times$ 1.6[mm] (occupied copper area : 70mm $\times$ 70mm).

(*17) (*19) Mounted on a glass epoxy 4 layers PCB 70[mm] $\times$ 70[mm] $\times$ 1.6[mm] (occupied copper area : 70mm $\times$ 70mm).

Fig. 99 Derating curve

●Operational Notes

- 1) Unused circuits
When there are unused circuits it is recommended that they are connected as in Fig.100, setting the non-inverting input terminal to a potential within input common-mode voltage range (V_{icm}).
- 2) Input terminal voltage
Applying GND + 36V to the input terminal is possible without causing deterioration of the electrical characteristics or destruction, irrespective of the supply voltage. However, this does not ensure normal circuit operation. Please note that the circuit operates normally only when the input voltage is within the common mode input voltage range of the electric characteristics.
- 3) Power supply (single / dual)
The op-amp operates when the specified voltage supplied is between VCC and VEE. Therefore, the single supply op-amp can be used as dual supply op-amp as well.
- 4) Power dissipation P_d
Using the unit in excess of the rated power dissipation may cause deterioration in electrical characteristics due to a rise in chip temperature, including reduced current capability. Therefore, please take into consideration the power dissipation (P_d) under actual operating conditions and apply a sufficient margin in thermal design. Refer to the thermal derating curves for more information.
- 5) Short-circuit between pins and erroneous mounting
Incorrect mounting may damage the IC. In addition, the presence of foreign particles between the outputs, the output and the power supply, or the output and GND may result in IC destruction.
- 6) Operation in a strong electromagnetic field
Operation in a strong electromagnetic field may cause malfunctions.
- 7) Radiation
This IC is not designed to withstand radiation.
- 8) IC handling
Applying mechanical stress to the IC by deflecting or bending the board may cause fluctuations in the electrical characteristics due to piezoelectric (piezo) effects.
- 9) Board inspection
Connecting a capacitor to a pin with low impedance may stress the IC. Therefore, discharging the capacitor after every process is recommended. In addition, when attaching and detaching the jig during the inspection phase, ensure that the power is turned OFF before inspection and removal. Furthermore, please take measures against ESD in the assembly process as well as during transportation and storage.
- 10) Output capacitor
Discharge of the external output capacitor to VCC is possible via internal parasitic elements when VCC is shorted to VEE, causing damage to the internal circuitry due to thermal stress. Therefore, when using this IC in circuits where oscillation due to output capacitive load does not occur, such as in voltage comparators, use an output capacitor with a capacitance less than 0.1μF.

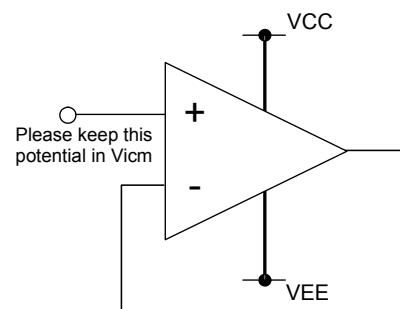


Fig.100 Unused circuit example

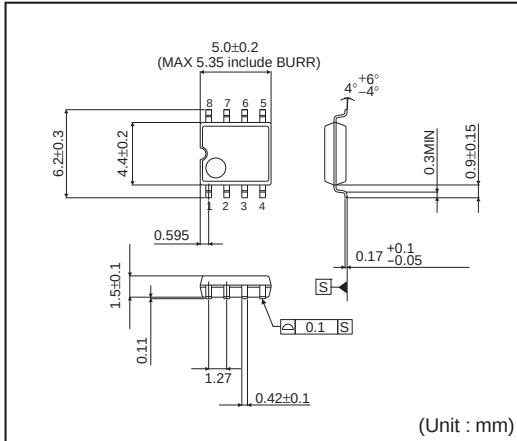
Status of this document

The Japanese version of this document is formal specification. A customer may use this translation version only for a reference to help reading the formal version.

If there are any differences in translation version of this document formal version takes priority.

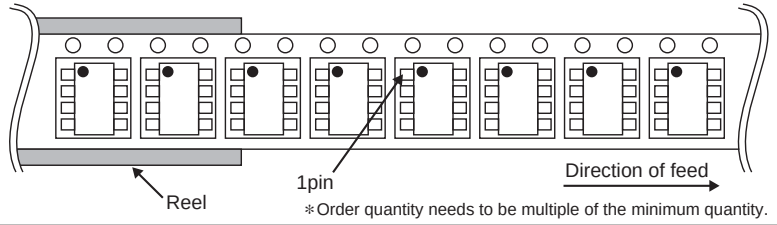
●Physical Dimensions Tape and Reel Information

SOP8

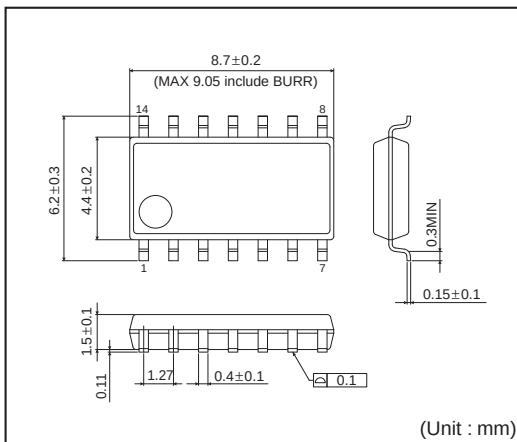


<Tape and Reel information>

Tape	Embossed carrier tape
Quantity	2500pcs
Direction of feed	E2 (The direction is the 1pin of product is at the upper left when you hold reel on the left hand and you pull out the tape on the right hand)

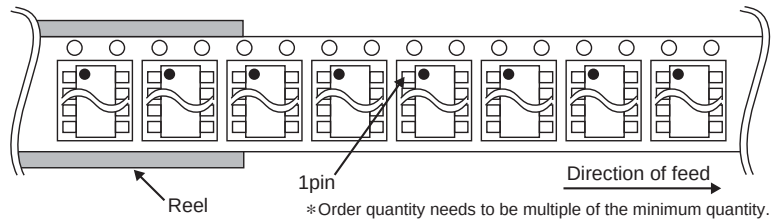


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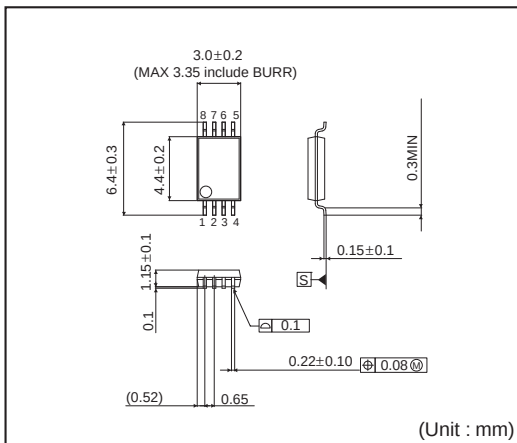


<Tape and Reel information>

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Quantity	2500pcs
Direction of feed	E2 (The direction is the 1pin of product is at the upper left when you hold reel on the left hand and you pull out the tape on the right hand)

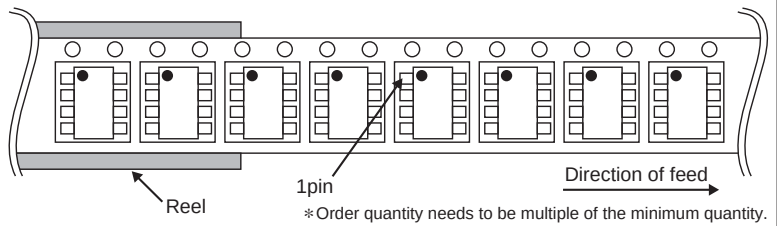


SSOP-B8

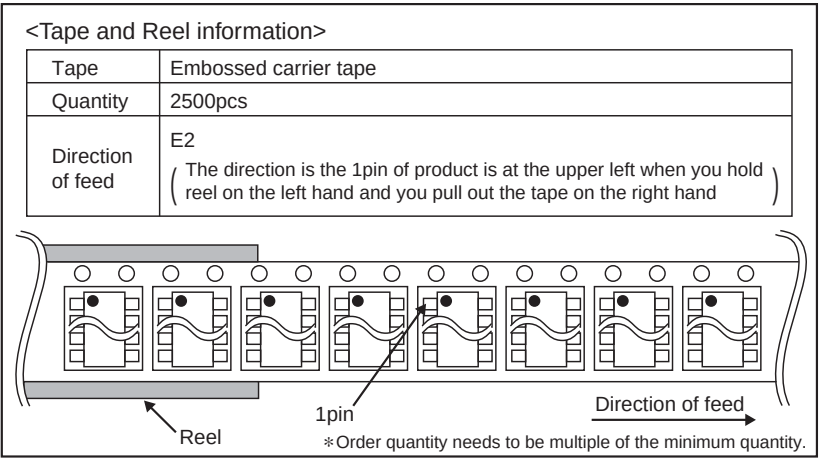
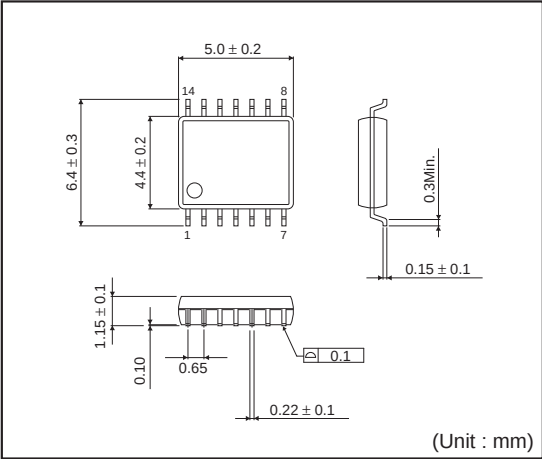


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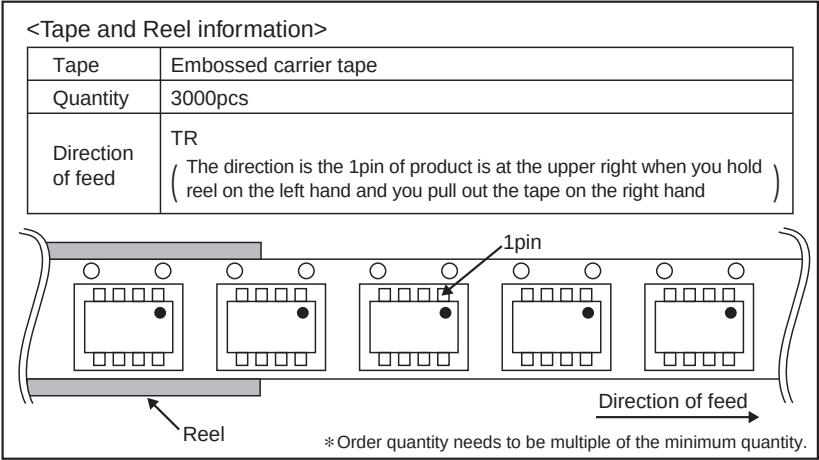
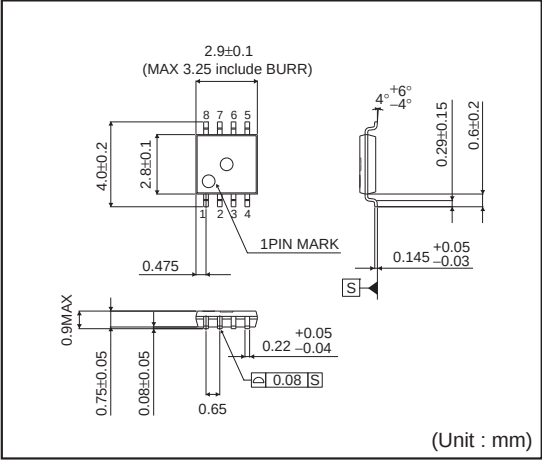
Tape	Embossed carrier tape
Quantity	2500pcs
Direction of feed	E2 (The direction is the 1pin of product is at the upper left when you hold reel on the left hand and you pull out the tape on the right hand)



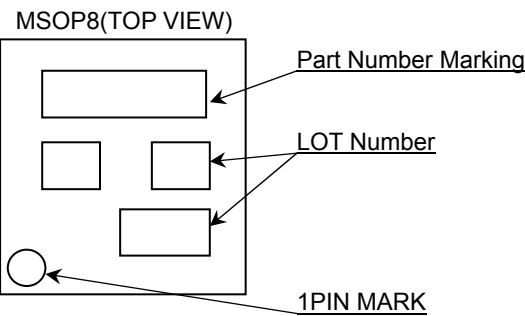
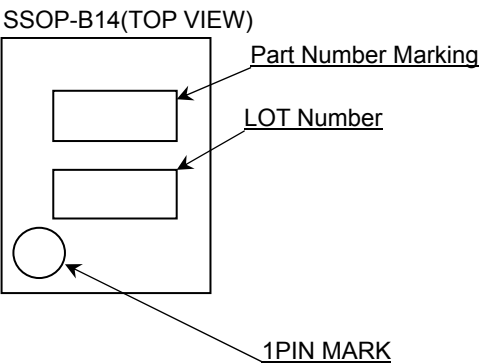
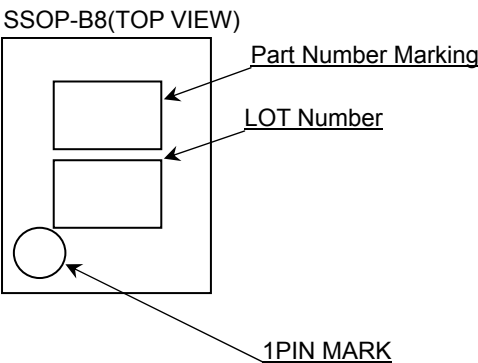
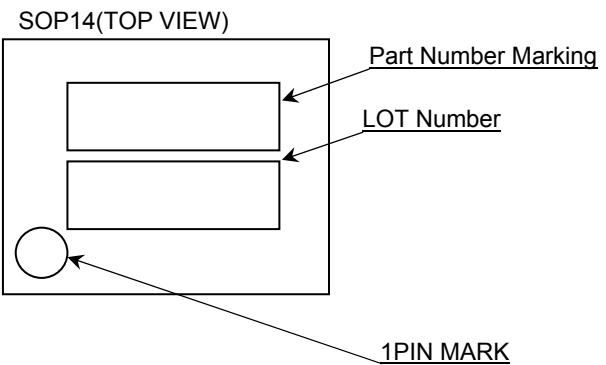
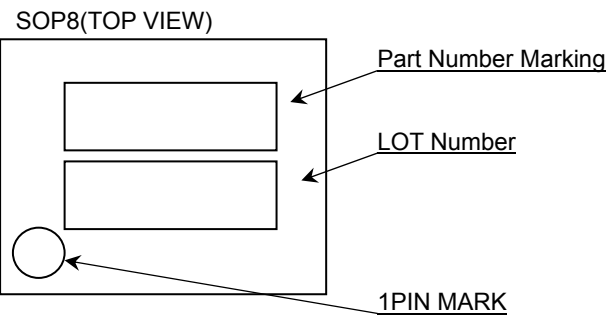
SSOP-B14



MSOP8



●Marking Diagrams



Product Name		Package Type	Marking
BA3472	F	SOP8S	3472
	FV	SSOP-B8	
	FVM	MSOP8	
	RFVM	MSOP8	3472R
BA3474	F	SOP14	3474F
	FV	SSOP-B14	3474
	RFV	SSOP-B14	3474R

Notice

●Precaution for circuit design

- 1) The products are designed and produced for application in ordinary electronic equipment (AV equipment, OA equipment, telecommunication equipment, home appliances, amusement equipment, etc.). If the products are to be used in devices requiring extremely high reliability (medical equipment, transport equipment, aircraft/spacecraft, nuclear power controllers, fuel controllers, car equipment including car accessories, safety devices, etc.) and whose malfunction or operational error may endanger human life and sufficient fail-safe measures, please consult with the ROHM sales staff in advance. If product malfunctions may result in serious damage, including that to human life, sufficient fail-safe measures must be taken, including the following:
 - [a] Installation of protection circuits or other protective devices to improve system safety
 - [b] Installation of redundant circuits in the case of single-circuit failure
- 2) The products are designed for use in a standard environment and not in any special environments. Application of the products in a special environment can deteriorate product performance. Accordingly, verification and confirmation of product performance, prior to use, is recommended if used under the following conditions:
 - [a] Use in various types of liquid, including water, oils, chemicals, and organic solvents
 - [b] Use outdoors where the products are exposed to direct sunlight, or in dusty places
 - [c] Use in places where the products are exposed to sea winds or corrosive gases, including Cl₂, H₂S, NH₃, SO₂, and NO₂
 - [d] Use in places where the products are exposed to static electricity or electromagnetic waves
 - [e] Use in proximity to heat-producing components, plastic cords, or other flammable items
 - [f] Use involving sealing or coating the products with resin or other coating materials
 - [g] Use involving unclean solder or use of water or water-soluble cleaning agents for cleaning after soldering
 - [h] Use of the products in places subject to dew condensation
- 3) The products are not radiation resistant.
- 4) Verification and confirmation of performance characteristics of products, after on-board mounting, is advised.
- 5) In particular, if a transient load (a large amount of load applied in a short period of time, such as pulse) is applied, confirmation of performance characteristics after on-board mounting is strongly recommended. Avoid applying power exceeding normal rated power; exceeding the power rating under steady-state loading condition may negatively affect product performance and reliability.
- 6) De-rate Power Dissipation (Pd) depending on Ambient temperature (Ta).
When used in sealed area, confirm the actual ambient temperature.
- 7) Confirm that operation temperature is within the specified range described in product specification.
- 8) Failure induced under deviant condition from what defined in the product specification cannot be guaranteed.

●Precaution for Mounting / Circuit board design

- 1) When a highly active halogenous (chlorine, bromine, etc.) flux is used, the remainder of flux may negatively affect product performance and reliability.
- 2) In principle, the reflow soldering method must be used; if flow soldering method is preferred, please consult with the Company in advance.

Regarding Precaution for Mounting / Circuit board design, please specially refer to ROHM Mounting specification

●Precautions Regarding Application Examples and External Circuits

- 1) If change is made to the constant of an external circuit, allow a sufficient margin due to variations of the characteristics of the products and external components, including transient characteristics, as well as static characteristics.
- 2) The application examples, their constants, and other types of information contained herein are applicable only when the products are used in accordance with standard methods. Therefore, if mass production is intended, sufficient consideration to external conditions must be made.

●**Precaution for Electrostatic**

This product is Electrostatic sensitive product, which may be damaged due to Electrostatic discharge. Please take proper caution during manufacturing and storing so that voltage exceeding Product maximum rating won't be applied to products. Please take special care under dry condition (e.g. Grounding of human body / equipment / solder iron, isolation from charged objects, setting of Ionizer, friction prevention and temperature / humidity control).

●**Precaution for Storage / Transportation**

- 1) Product performance and soldered connections may deteriorate if the products are stored in the following places:
 - [a] Where the products are exposed to sea winds or corrosive gases, including Cl₂, H₂S, NH₃, SO₂, and NO₂
 - [b] Where the temperature or humidity exceeds those recommended by the Company
 - [c] Storage in direct sunshine or condensation
 - [d] Storage in high Electrostatic
- 2) Even under ROHM recommended storage condition, solderability of products out of recommended storage time period may be degraded. It is strongly recommended to confirm solderability before using products of which storage time is exceeding recommended storage time period .
- 3) Store / transport cartons in the correct direction, which is indicated on a carton as a symbol. Otherwise bent leads may occur due to excessive stress applied when dropping of a carton.
- 4) Use products within the specified time after opening a dry bag.

●**Precaution for product label**

QR code printed on ROHM product label is only for internal use, and please do not use at customer site. It might contain a internal part number that is inconsistent with an product part number.

●**Precaution for disposition**

When disposing products please dispose them properly with a industry waste company.

●**Precaution for Foreign exchange and Foreign trade act**

Since concerned goods might be fallen under controlled goods prescribed by Foreign exchange and Foreign trade act, please consult with ROHM in case of export.

●**Prohibitions Regarding Industrial Property**

- 1) Information and data on products, including application examples, contained in these specifications are simply for reference; the Company does not guarantee any industrial property rights, intellectual property rights, or any other rights of a third party regarding this information or data. Accordingly, the Company does not bear any responsibility for:
 - [a] infringement of the intellectual property rights of a third party
 - [b] any problems incurred by the use of the products listed herein.
- 2) The Company prohibits the purchaser of its products to exercise or use the intellectual property rights, industrial property rights, or any other rights that either belong to or are controlled by the Company, other than the right to use, sell, or dispose of the products.